



3.3 VOLT HIGH-DENSITY SUPERSYNC™ II 36-BIT FIFO

1,024 x 36, 2,048 x 36
4,096 x 36, 8,192 x 36
16,384 x 36, 32,768 x 36
65,536 x 36, 131,072 x 36

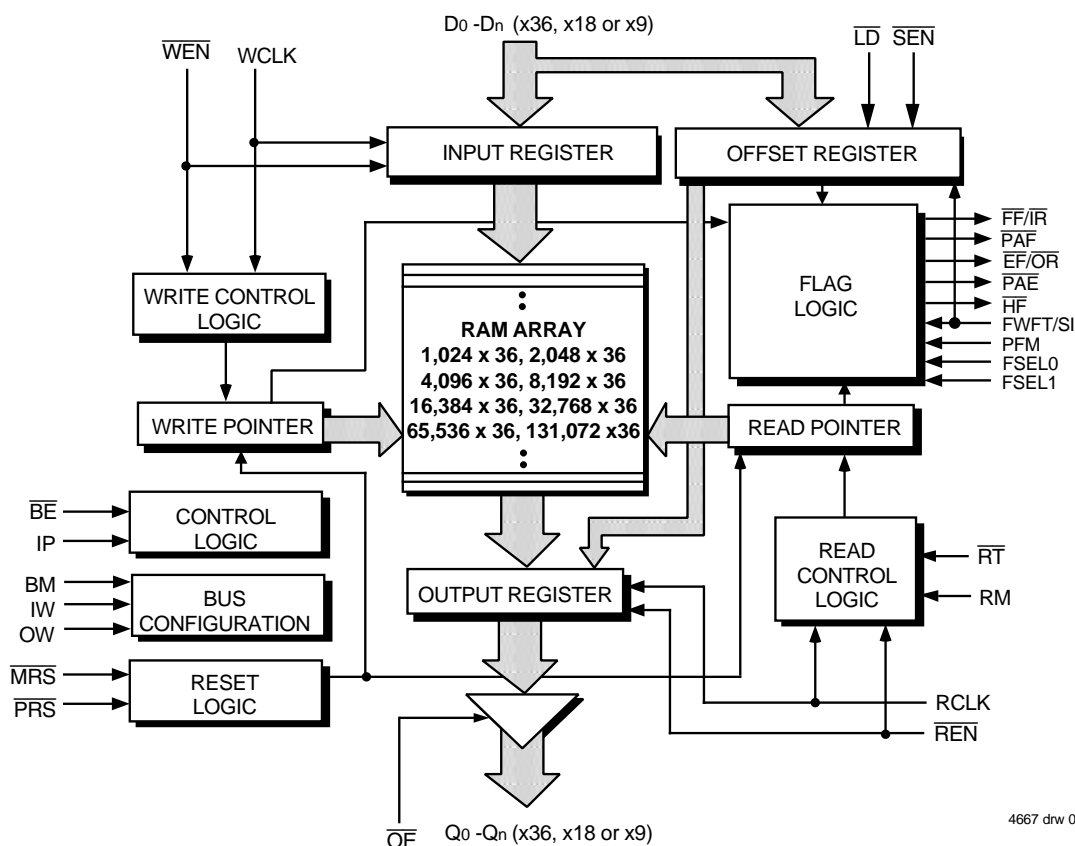
IDT72V3640, IDT72V3650
IDT72V3660, IDT72V3670
IDT72V3680, IDT72V3690
IDT72V36100, IDT72V36110

FEATURES:

- Choose among the following memory organizations:
 - IDT72V3640 — 1,024 x 36
 - IDT72V3650 — 2,048 x 36
 - IDT72V3660 — 4,096 x 36
 - IDT72V3670 — 8,192 x 36
 - IDT72V3680 — 16,384 x 36
 - IDT72V3690 — 32,768 x 36
 - IDT72V36100 — 65,536 x 36
 - IDT72V36110 — 131,072 x 36
- 133 MHz operation (7.5 ns read/write cycle time)
- User selectable input and output port bus-sizing
 - x36 in to x36 out
 - x36 in to x18 out
 - x36 in to x9 out
 - x18 in to x36 out
 - x9 in to x36 out
- Big-Endian/Little-Endian user selectable byte representation
- 5V input tolerant
- Fixed, low first word latency

- Zero latency retransmit
- Auto power down minimizes standby power consumption
- Master Reset clears entire FIFO
- Partial Reset clears data, but retains programmable settings
- Empty, Full and Half-Full flags signal FIFO status
- Programmable Almost-Empty and Almost-Full flags, each flag can default to one of eight preselected offsets
- Selectable synchronous/asynchronous timing modes for Almost-Empty and Almost-Full flags
- Program programmable flags by either serial or parallel means
- Select IDT Standard timing (using \overline{EF} and \overline{FF} flags) or First Word Fall Through timing (using \overline{OR} and \overline{IR} flags)
- Output enable puts data outputs into high impedance state
- Easily expandable in depth and width
- Independent Read and Write Clocks (permit reading and writing simultaneously)
- Available in the 128-pin Thin Quad Flat Pack (TQFP)
- High-performance submicron CMOS technology
- Industrial temperature range (-40°C to +85°C) is available

FUNCTIONAL BLOCK DIAGRAM



4667 drw 01

The SuperSync II FIFO is a trademark and the IDT logo is a registered trademark of Integrated Device Technology, Inc.

COMMERCIAL AND INDUSTRIAL TEMPERATURE RANGES

APRIL 2001

DESCRIPTION:

The IDT72V3640/72V3650/72V3660/72V3670/72V3680/72V3690/72V36100/72V36110 are exceptionally deep, high speed, CMOS First-In-First-Out (FIFO) memories with clocked read and write controls and a flexible Bus-Matching x36/x18/x9 data flow. These FIFOs offer several key user benefits:

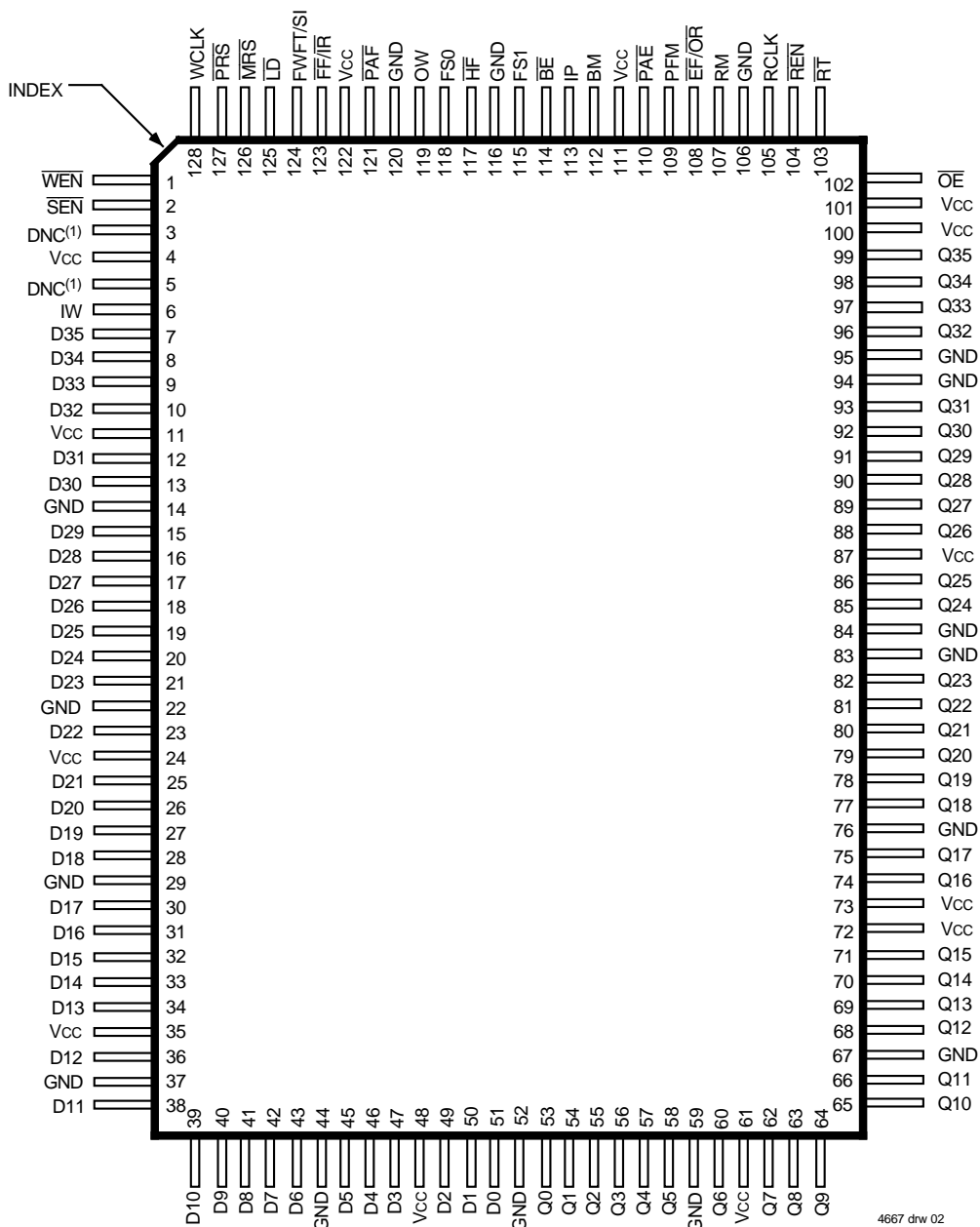
- Flexible x36/x18/x9 Bus-Matching on both read and write ports
- The period required by the retransmit operation is fixed and short.
- The first word data latency period, from the time the first word is written to an empty FIFO to the time it can be read, is fixed and short.
- High density offerings up to 4 Mbit

Bus-Matching Sync FIFOs are particularly appropriate for network, video, telecommunications, data communications and other applications that need to buffer large amounts of data and match busses of unequal sizes.

Each FIFO has a data input port (D_n) and a data output port (Q_n), both of which can assume either a 36-bit, 18-bit or a 9-bit width as determined by the state of external control pins Input Width (IW), Output Width (OW), and Bus-Matching (BM) pin during the Master Reset cycle.

The input port is controlled by a Write Clock (WCLK) input and a Write Enable (\overline{WEN}) input. Data is written into the FIFO on every rising edge of WCLK when \overline{WEN} is asserted. The output port is controlled by a Read Clock (RCLK) input and Read Enable (\overline{REN}) input. Data is read from the FIFO on every rising edge

PIN CONFIGURATIONS



TQFP (PK128-1, order code: PF)
TOP VIEW

NOTE:

1. DNC = Do Not Connect.

DESCRIPTION (CONTINUED)

of RCLK when \overline{REN} is asserted. An Output Enable (\overline{OE}) input is provided for three-state control of the outputs.

The frequencies of both the RCLK and the WCLK signals may vary from 0 to fMAX with complete independence. There are no restrictions on the frequency of the one clock input with respect to the other.

There are two possible timing modes of operation with these devices: IDT Standard mode and First Word Fall Through (FWFT) mode.

In *IDT Standard mode*, the first word written to an empty FIFO will not appear on the data output lines unless a specific read operation is performed. A read operation, which consists of activating \overline{REN} and enabling a rising RCLK edge, will shift the word from internal memory to the data output lines.

In *FWFT mode*, the first word written to an empty FIFO is clocked directly to the data output lines after three transitions of the RCLK signal. A \overline{REN} does not have to be asserted for accessing the first word. However, subsequent words written to the FIFO do require a LOW on \overline{REN} for access. The state of the FWFT/SI input during Master Reset determines the timing mode in use.

For applications requiring more data storage capacity than a single FIFO can provide, the FWFT timing mode permits depth expansion by chaining FIFOs in series (i.e. the data outputs of one FIFO are connected to the corresponding data inputs of the next). No external logic is required.

These FIFOs have five flag pins, $\overline{EF}/\overline{OR}$ (Empty Flag or Output Ready), $\overline{FF}/\overline{IR}$ (Full Flag or Input Ready), \overline{HF} (Half-full Flag), \overline{PAE} (Programmable Almost-Empty flag) and \overline{PAF} (Programmable Almost-Full flag). The \overline{EF} and \overline{FF} functions are selected in IDT Standard mode. The \overline{IR} and \overline{OR} functions are selected in FWFT mode. \overline{HF} , \overline{PAE} and \overline{PAF} are always available for use, irrespective of timing mode.

\overline{PAE} and \overline{PAF} can be programmed independently to switch at any point in memory. Programmable offsets determine the flag switching threshold and can be loaded by two methods: parallel or serial. Eight default offset settings are also

provided, so that \overline{PAE} can be set to switch at a predefined number of locations from the empty boundary and the \overline{PAF} threshold can also be set at similar predefined values from the full boundary. The default offset values are set during Master Reset by the state of the FSEL0, FSEL1, and \overline{LD} pins.

For serial programming, \overline{SEN} together with \overline{LD} on each rising edge of WCLK, are used to load the offset registers via the Serial Input (SI). For parallel programming, \overline{WEN} together with \overline{LD} on each rising edge of WCLK, are used to load the offset registers via D_n . \overline{REN} together with \overline{LD} on each rising edge of RCLK can be used to read the offsets in parallel from Q_n regardless of whether serial or parallel offset loading has been selected.

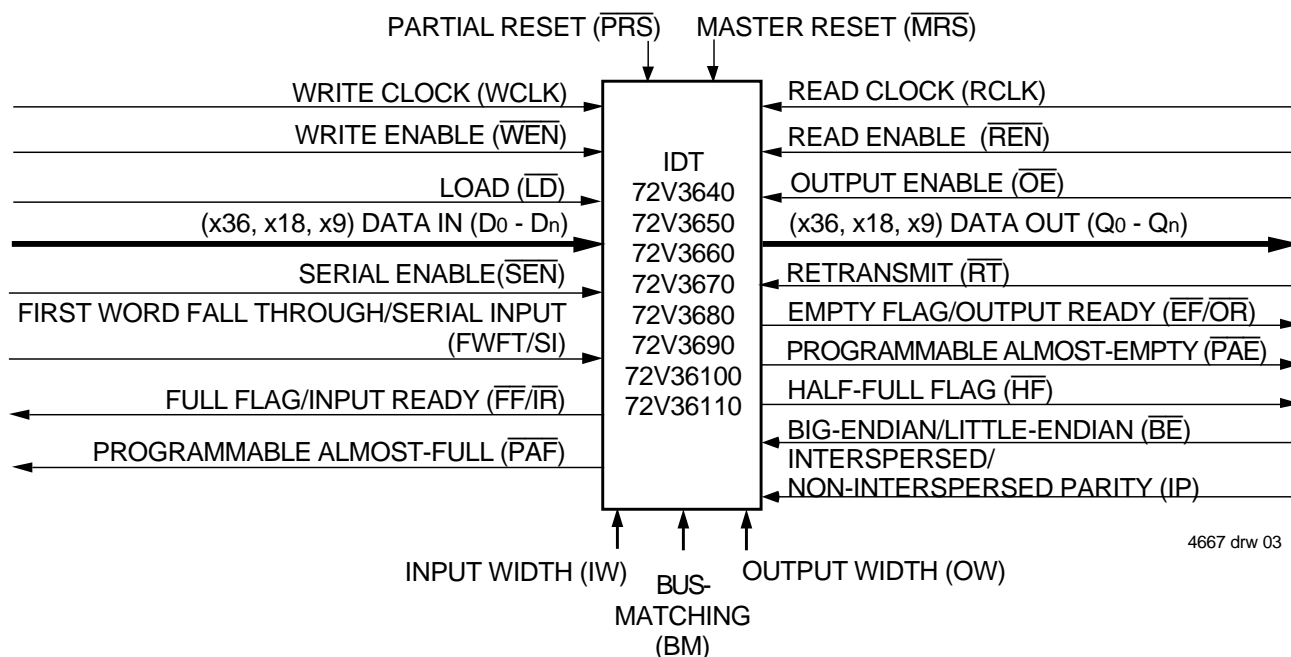
During Master Reset (MRS) the following events occur: the read and write pointers are set to the first location of the FIFO. The FWFT pin selects IDT Standard mode or FWFT mode.

The Partial Reset (PRS) also sets the read and write pointers to the first location of the memory. However, the timing mode, programmable flag programming method, and default or programmed offset settings existing before Partial Reset remain unchanged. The flags are updated according to the timing mode and offsets in effect. \overline{PRS} is useful for resetting a device in mid-operation, when reprogramming programmable flags would be undesirable.

It is also possible to select the timing mode of the \overline{PAE} (Programmable Almost-Empty flag) and \overline{PAF} (Programmable Almost-Full flag) outputs. The timing modes can be set to be either asynchronous or synchronous for the \overline{PAE} and \overline{PAF} flags.

If asynchronous $\overline{PAE}/\overline{PAF}$ configuration is selected, the \overline{PAE} is asserted LOW on the LOW-to-HIGH transition of RCLK. \overline{PAE} is reset to HIGH on the LOW-to-HIGH transition of WCLK. Similarly, the \overline{PAF} is asserted LOW on the LOW-to-HIGH transition of WCLK and \overline{PAF} is reset to HIGH on the LOW-to-HIGH transition of RCLK.

If synchronous $\overline{PAE}/\overline{PAF}$ configuration is selected, the \overline{PAE} is asserted and updated on the rising edge of RCLK only and not WCLK. Similarly, \overline{PAF} is



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Figure 1. Single Device Configuration Signal Flow Diagram

asserted and updated on the rising edge of WCLK only and not RCLK. The mode desired is configured during Master Reset by the state of the Programmable Flag Mode (PFM) pin.

The Retransmit function allows data to be reread from the FIFO more than once. A LOW on the RT input during a rising RCLK edge initiates a retransmit operation by setting the read pointer to the first location of the memory array. A zero-latency retransmit timing mode can be selected using the Retransmit timing Mode pin (RM). During Master Reset, a LOW on RM will select zero latency retransmit. A HIGH on RM during Master Reset will select normal latency.

If zero latency retransmit operation is selected, the first data word to be retransmitted will be placed on the output register with respect to the same RCLK edge that initiated the retransmit based on RT being LOW.

Refer to Figure 11 and 12 for *Retransmit Timing* with normal latency. Refer to Figure 13 and 14 for *Zero Latency Retransmit Timing*.

The device can be configured with different input and output bus widths as shown in Table 1.

A Big-Endian/Little-Endian data word format is provided. This function is useful when data is written into the FIFO in long word format (x36/x18) and read out of the FIFO in small word (x18/x9) format. If Big-Endian mode is selected, then the most significant byte (word) of the long word written into the FIFO will

be read out of the FIFO first, followed by the least significant byte. If Little-Endian format is selected, then the least significant byte of the long word written into the FIFO will be read out first, followed by the most significant byte. The mode desired is configured during master reset by the state of the Big-Endian (BE) pin. See Figure 4 for *Bus-Matching Byte Arrangement*.

The Interspersed/Non-Interspersed Parity (IP) bit function allows the user to select the parity bit in the word loaded into the parallel port (D0-Dn) when programming the flag offsets. If Interspersed Parity mode is selected, then the FIFO will assume that the parity bit is located in bit positions D8, D17, D26 and D35 during the parallel programming of the flag offsets. If Non-Interspersed Parity mode is selected, then D8, D17 and D26 are assumed to be valid bits and D32, D33, D34 and D35 are ignored. IP mode is selected during Master Reset by the state of the IP input pin. Interspersed Parity control only has an effect during parallel programming of the offset registers. It does not effect the data written to and read from the FIFO.

If, at any time, the FIFO is not actively performing an operation, the chip will automatically power down. Once in the power down state, the standby supply current consumption is minimized. Initiating any operation (by activating control inputs) will immediately take the device out of the power down state.

The IDT72V3640/72V3650/72V3660/72V3670/72V3680/72V3690/72V36100/72V36110 are fabricated using IDT's high speed submicron CMOS technology.

TABLE 1 — BUS-MATCHING CONFIGURATION MODES

BM	IW	OW	Write Port Width	Read Port Width
L	L	L	x36	x36
H	L	L	x36	x18
H	L	H	x36	x9
H	H	L	x18	x36
H	H	H	x9	x36

NOTE:

1. Pin status during Master Reset.

PIN DESCRIPTION

Symbol	Name	I/O	Description
D0–D35	Data Inputs	I	Data inputs for a 36-, 18- or 9-bit bus. When in 18- or 9-bit mode, the unused input pins are in a don't care state.
MRS	Master Reset	I	MRS initializes the read and write pointers to zero and sets the output register to all zeroes. During Master Reset, the FIFO is configured for either FWFT or IDT Standard mode, Bus-Matching configurations, one of eight programmable flag default settings, serial or parallel programming of the offset settings, Big-Endian/Little-Endian format, zero latency timing mode, interspersed parity, and synchronous versus asynchronous programmable flag timing modes.
PRS	Partial Reset	I	PRS initializes the read and write pointers to zero and sets the output register to all zeroes. During Partial Reset, the existing mode (IDT or FWFT), programming method (serial or parallel), and programmable flag settings are all retained.
RT	Retransmit	I	RT asserted on the rising edge of RCLK initializes the READ pointer to zero, sets the EF flag to LOW (OR to HIGH in FWFT mode) and does not disturb the write pointer, programming method, existing timing mode or programmable flag settings. RT is useful to reread data from the first physical location of the FIFO.
FWFT/SI	First Word Fall Through/Serial In	I	During Master Reset, selects First Word Fall Through or IDT Standard mode. After Master Reset, this pin functions as a serial input for loading offset registers.
OW ⁽¹⁾	Output Width	I	This pin, along with IW and BM, selects the bus width of the read port. See Table 1 for bus size configuration.
IW ⁽¹⁾	Input Width	I	This pin, along with OW and MB, selects the bus width of the write port. See Table 1 for bus size configuration.
BM ⁽¹⁾	Bus-Matching	I	BM works with IW and OW to select the bus sizes for both write and read ports. See Table 1 for bus size configuration.
BE ⁽¹⁾	Big-Endian/Little-Endian	I	During Master Reset, a LOW on BE will select Big-Endian operation. A HIGH on BE during Master Reset will select Little-Endian format.
RM ⁽¹⁾	Retransmit Timing Mode	I	During Master Reset, a LOW on RM will select zero latency Retransmit timing Mode. A HIGH on RM will select normal latency mode.
PFM ⁽¹⁾	Programmable Flag Mode	I	During Master Reset, a LOW on PFM will select Asynchronous Programmable flag timing mode. A HIGH on PFM will select Synchronous Programmable flag timing mode.
IP ⁽¹⁾	Interspersed Parity	I	During Master Reset, a LOW on IP will select Non-Interspersed Parity mode. A HIGH will select Interspersed Parity mode. Interspersed Parity control only has an effect during parallel programming of the offset registers. It does not effect the data written to and read from the FIFO.
FSEL0 ⁽¹⁾	Flag Select Bit 0	I	During Master Reset, this input along with FSEL1 and the LD pin, will select the default offset values for the programmable flags PAE and PAF. There are up to eight possible settings available.
FSEL1 ⁽¹⁾	Flag Select Bit 1	I	During Master Reset, this input along with FSEL0 and the LD pin will select the default offset values for the programmable flags PAE and PAF. There are up to eight possible settings available.
WCLK	Write Clock	I	When enabled by WEN, the rising edge of WCLK writes data into the FIFO and offsets into the programmable registers for parallel programming, and when enabled by SEN, the rising edge of WCLK writes one bit of data into the programmable register for serial programming.
WEN	Write Enable	I	WEN enables WCLK for writing data into the FIFO memory and offset registers.
RCLK	Read Clock	I	When enabled by REN, the rising edge of RCLK reads data from the FIFO memory and offsets from the programmable registers.
REN	Read Enable	I	REN enables RCLK for reading data from the FIFO memory and offset registers.
OE	Output Enable	I	OE controls the output impedance of Qn.
SEN	Serial Enable	I	SEN enables serial loading of programmable flag offsets.
LD	Load	I	This is a dual purpose pin. During Master Reset, the state of the LD input along with FSEL0 and FSEL1, determines one of eight default offset values for the PAE and PAF flags, along with the method by which these offset registers can be programmed, parallel or serial (see Table 2). After Master Reset, this pin enables writing to and reading from the offset registers.
FF/IR	Full Flag/	O	In the IDT Standard mode, the FF function is selected. FF indicates whether or Input Ready not the FIFO memory is full. In the FWFT mode, the IR function is selected. IR indicates whether or not there is space available for writing to the FIFO memory.
EF/OR	Empty Flag/Output Ready	O	In the IDT Standard mode, the EF function is selected. EF indicates whether or not the FIFO memory is empty. In FWFT mode, the OR function is selected. OR indicates whether or not there is valid data available at the outputs.
PAF	Programmable Almost-Full Flag	O	PAF goes HIGH if the number of free locations in the FIFO memory is more than offset m, which is stored in the Full Offset register. PAF goes LOW if the number of free locations in the FIFO memory is less than or equal to m.
PAE	Programmable Almost-Empty Flag	O	PAE goes LOW if the number of words in the FIFO memory is less than offset n, which is stored in the Empty Offset register. PAE goes HIGH if the number of words in the FIFO memory is greater than or equal to offset n.
HF	Half-Full Flag	O	HF indicates whether the FIFO memory is more or less than half-full.
Q0–Q35	Data Outputs	O	Data outputs for an 36-, 18- or 9-bit bus. When in 18- or 9-bit mode, the unused output pins are in a don't care state. Outputs are not 5V tolerant regardless of the state of OE.

NOTE:

- Inputs should not change state after Master Reset.

ABSOLUTE MAXIMUM RATINGS

Symbol	Rating	Com'l & Ind'l	Unit
VTERM ⁽²⁾	Terminal Voltage with respect to GND	-0.5 to +4.5	V
TSTG	Storage Temperature	-55 to +125	°C
IOUT	DC Output Current	-50 to +50	mA

NOTES:

- Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
- Vcc terminal only.

RECOMMENDED DC OPERATING CONDITIONS

Symbol	Parameter	Min.	Typ.	Max.	Unit
VCC ⁽¹⁾	Supply Voltage Com'l/Ind'l	3.15	3.3	3.45	V
GND	Supply Voltage Com'l/Ind'l	0	0	0	V
VIH ⁽²⁾	Input High Voltage Com'l/Ind'l	2.0	—	5.5	V
VIL ⁽³⁾	Input Low Voltage Com'l/Ind'l	—	—	0.8	V
TA	Operating Temperature Commercial	0	—	70	°C
TA	Operating Temperature Industrial	-40	—	85	°C

NOTES:

- Vcc = 3.3V ± 0.15V, JEDEC JESD8-A compliant.
- Outputs are not 5V tolerant.
- 1.5V undershoots are allowed for 10ns once per cycle.

DC ELECTRICAL CHARACTERISTICS

(Commercial: VCC = 3.3V ± 0.15V, TA = 0°C to +70°C; Industrial: VCC = 3.3V ± 0.15V, TA = -40°C to +85°C; JEDEC JESD8-A compliant)

Symbol	Parameter	IDT72V3640L IDT72V3650L IDT72V3660L IDT72V3670L IDT72V3680L IDT72V3690L IDT72V36100L IDT72V36110L Commercial and Industrial ⁽¹⁾ tCLK = 7.5, 10, 15 ns		Unit
		Min.	Max.	
ILI ⁽²⁾	Input Leakage Current	-1	1	μA
ILO ⁽³⁾	Output Leakage Current	-10	10	μA
VOH	Output Logic "1" Voltage, IOH = -2 mA	2.4	—	V
VOL	Output Logic "0" Voltage, IOL = 8 mA	—	0.4	V
ICC1 ^(4,5,6)	Active Power Supply Current	—	40	mA
ICC2 ^(4,7)	Standby Current	—	15	mA

NOTES:

- Industrial temperature range product for the 15ns speed grade is available as a standard device. All other speed grades are available by special order.
- Measurements with $0.4 \leq V_{IN} \leq V_{CC}$.
- $\overline{OE} \geq V_{IH}$, $0.4 \leq V_{OUT} \leq V_{CC}$.
- Tested with outputs open (IOUT = 0).
- RCLK and WCLK toggle at 20 MHz and data inputs switch at 10 MHz.
- Typical ICC1 = $4.2 + 1.4 \cdot f_s + 0.02 \cdot C_L \cdot f_s$ (in mA) with VCC = 3.3V, TA = 25°C, fs = WCLK frequency = RCLK frequency (in MHz, using TTL levels), data switching at fs/2, CL = capacitive load (in pF).
- All Inputs = VCC - 0.2V or GND + 0.2V, except RCLK and WCLK, which toggle at 20 MHz.

CAPACITANCE (TA = +25°C, f = 1.0MHz)

Symbol	Parameter ⁽¹⁾	Conditions	Max.	Unit
CIN ⁽²⁾	Input Capacitance	VIN = 0V	10	pF
COUT ^(1,2)	Output Capacitance	VOUT = 0V	10	pF

NOTES:

- With output deselected, ($\overline{OE} \geq V_{IH}$).
- Characterized values, not currently tested.

AC ELECTRICAL CHARACTERISTICS⁽¹⁾

(Commercial: VCC = 3.3V ± 0.15V, TA = 0°C to +70°C; Industrial: VCC = 3.3V ± 0.15V, TA = -40°C to +85°C; JEDEC JESD8-A compliant)

Symbol	Parameter	Commercial				Com'l & Ind'l ⁽²⁾		Unit
		IDT72V3640L7.5 IDT72V3650L7.5 IDT72V3660L7.5 IDT72V3670L7.5 IDT72V3680L7.5 IDT72V3690L7.5 IDT72V36100L7.5 IDT72V36110L7.5		IDT72V3640L10 IDT72V3650L10 IDT72V3660L10 IDT72V3670L10 IDT72V3680L10 IDT72V3690L10 IDT72V36100L10 IDT72V36110L10		IDT72V3640L15 IDT72V3650L15 IDT72V3660L15 IDT72V3670L15 IDT72V3680L15 IDT72V3690L15 IDT72V36100L15 IDT72V36110L15		
		Min.	Max.	Min.	Max.	Min.	Max.	
fs	Clock Cycle Frequency	—	133.3	—	100	—	66.7	MHz
tA	Data Access Time	2	5	2	6.5	2	10	ns
tCLK	Clock Cycle Time	7.5	—	10	—	15	—	ns
tCLKH	Clock High Time	3.5	—	4.5	—	6	—	ns
tCLKL	Clock Low Time	3.5	—	4.5	—	6	—	ns
tDS	Data Setup Time	2.5	—	3.5	—	4	—	ns
tDH	Data Hold Time	0.5	—	0.5	—	1	—	ns
tENS	Enable Setup Time	2.5	—	3.5	—	4	—	ns
tENH	Enable Hold Time	0.5	—	0.5	—	1	—	ns
tLDS	Load Setup Time	3.5	—	3.5	—	4	—	ns
tLDH	Load Hold Time	0.5	—	0.5	—	1	—	ns
tRS	Reset Pulse Width ⁽³⁾	10	—	10	—	15	—	ns
tRSS	Reset Setup Time	15	—	15	—	15	—	ns
tRSR	Reset Recovery Time	10	—	10	—	15	—	ns
tRSF	Reset to Flag and Output Time	—	15	—	15	—	15	ns
tRTS	Retransmit Setup Time	3.5	—	3.5	—	4	—	ns
tOLZ	Output Enable to Output in Low Z ⁽⁴⁾	0	—	0	—	0	—	ns
tOE	Output Enable to Output Valid	2	6	2	6	2	8	ns
tOHZ	Output Enable to Output in High Z ⁽⁴⁾	2	6	2	6	2	8	ns
tWFF	Write Clock to \overline{FF} or \overline{IR}	—	5	—	6.5	—	10	ns
tREF	Read Clock to \overline{EF} or \overline{OR}	—	5	—	6.5	—	10	ns
tPAFA	Clock to Asynchronous Programmable Almost-Full Flag	—	12.5	—	16	—	20	ns
tPAFS	Write Clock to Synchronous Programmable Almost-Full Flag	—	5	—	6.5	—	10	ns
tPAEA	Clock to Asynchronous Programmable Almost-Empty Flag	—	12.5	—	16	—	20	ns
tPAES	Read Clock to Synchronous Programmable Almost-Empty Flag	—	5	—	6.5	—	10	ns
tHF	Clock to \overline{HF}	—	12.5	—	16	—	20	ns
tSKEW1	Skew time between RCLK and WCLK for $\overline{EF}/\overline{OR}$ and $\overline{FF}/\overline{IR}$	5	—	7	—	9	—	ns
tSKEW2	Skew time between RCLK and WCLK for \overline{PAE} and \overline{PAF}	7	—	10	—	14	—	ns

NOTES:

1. All AC timings apply to both Standard IDT mode and First Word Fall Through mode.
2. Industrial temperature range is available by special order for speed grades faster than 15ns.
3. Pulse widths less than minimum values are not allowed.
4. Values guaranteed by design, not currently tested.

AC TEST CONDITIONS

Input Pulse Levels	GND to 3.0V
Input Rise/Fall Times	3ns ⁽¹⁾
Input Timing Reference Levels	1.5V
Output Reference Levels	1.5V
Output Load for t _{CLK} = 10ns, 15 ns	See Figure 2a
Output Load for t _{CLK} = 7.5ns	See Figure 2b & 2c

NOTE:

1. For 133MHz operation input rise/fall times are 1.5ns.

AC TEST LOADS - 7.5ns Speed Grade

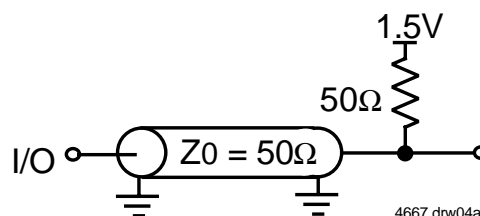


Figure 2b. AC Test Load

AC TEST LOADS - 10ns, 15ns Speed Grades

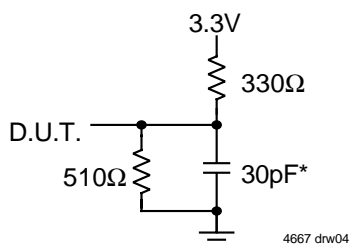


Figure 2a. Output Load

* Includes jig and scope capacitances.

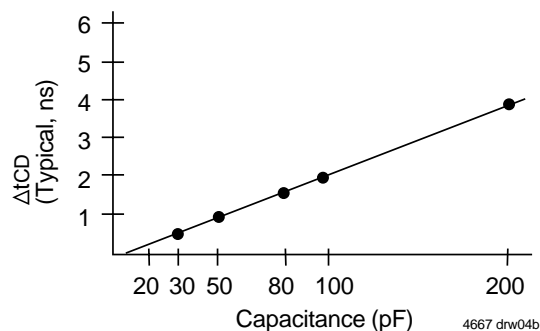


Figure 2c. Lumped Capacitive Load, Typical Derating

FUNCTIONAL DESCRIPTION

TIMING MODES: IDT STANDARD vs FIRST WORD FALL THROUGH (FWFT) MODE

The IDT72V3640/72V3650/72V3660/72V3670/72V3680/72V3690/72V36100/72V36110 support two different timing modes of operation: IDT Standard mode or First Word Fall Through (FWFT) mode. The selection of which mode will operate is determined during Master Reset, by the state of the FWFT/SI input.

If, at the time of Master Reset, FWFT/SI is LOW, then IDT Standard mode will be selected. This mode uses the Empty Flag (\overline{EF}) to indicate whether or not there are any words present in the FIFO. It also uses the Full Flag function (\overline{FF}) to indicate whether or not the FIFO has any free space for writing. In IDT Standard mode, every word read from the FIFO, including the first, must be requested using the Read Enable (\overline{REN}) and RCLK.

If, at the time of Master Reset, FWFT/SI is HIGH, then FWFT mode will be selected. This mode uses Output Ready (\overline{OR}) to indicate whether or not there is valid data at the data outputs (Q_n). It also uses Input Ready (\overline{IR}) to indicate whether or not the FIFO has any free space for writing. In the FWFT mode, the first word written to an empty FIFO goes directly to Q_n after three RCLK rising edges, $\overline{REN} = \text{LOW}$ is not necessary. Subsequent words must be accessed using the Read Enable (\overline{REN}) and RCLK.

Various signals, both input and output signals operate differently depending on which timing mode is in effect.

IDT STANDARD MODE

In this mode, the status flags, \overline{FF} , \overline{PAF} , \overline{HF} , \overline{PAE} , and \overline{EF} operate in the manner outlined in Table 3. To write data into the FIFO, Write Enable (\overline{WEN}) must be LOW. Data presented to the DATA IN lines will be clocked into the FIFO on subsequent transitions of the Write Clock (WCLK). After the first write is performed, the Empty Flag (\overline{EF}) will go HIGH. Subsequent writes will continue to fill up the FIFO. The Programmable Almost-Empty flag (\overline{PAE}) will go HIGH after $n + 1$ words have been loaded into the FIFO, where n is the empty offset value. The default setting for these values are stated in the footnote of Table 2. This parameter is also user programmable. See section on Programmable Flag Offset Loading.

If one continued to write data into the FIFO, and we assumed no read operations were taking place, the Half-Full flag (\overline{HF}) would toggle to LOW once the 513rd word for IDT72V3640, 1,025th word for IDT72V3650, 2,049th word for IDT72V3660, 4,097th word for IDT72V3670, 8,193th word for the IDT72V3680, 16,385th word for the IDT72V3690, 32,769th word for the IDT72V36100 and 65,537th word for the IDT72V36110, respectively was written into the FIFO. Continuing to write data into the FIFO will cause the Programmable Almost-Full flag (\overline{PAF}) to go LOW. Again, if no reads are performed, the \overline{PAF} will go LOW after (1,024- m) writes for the IDT72V3640, (2,048- m) writes for the IDT72V3650, (4,096- m) writes for the IDT72V3660, (8,192- m) writes for the IDT72V3670, (16,384- m) writes for the IDT72V3680, (32,768- m) writes for the IDT72V3690, (65,536- m) writes for the IDT72V36100 and (131,072- m) writes for the IDT72V36110. The offset "m" is the full offset value. The default setting for these values are stated in the footnote of Table 2. This parameter is also user programmable. See section on Programmable Flag Offset Loading.

When the FIFO is full, the Full Flag (\overline{FF}) will go LOW, inhibiting further write operations. If no reads are performed after a reset, \overline{FF} will go LOW after D writes to the FIFO. $D = 1,024$ writes for the IDT72V3640, 2,048 writes for the IDT72V3650, 4,096 writes for the IDT72V3660, 8,192 writes for the IDT72V3670, 16,384 writes for the IDT72V3680, 32,768 writes for the IDT72V3690, 65,536

writes for the IDT72V36100 and 131,072 writes for the IDT72V36110, respectively.

If the FIFO is full, the first read operation will cause \overline{FF} to go HIGH. Subsequent read operations will cause \overline{PAF} and \overline{HF} to go HIGH at the conditions described in Table 3. If further read operations occur, without write operations, \overline{PAE} will go LOW when there are n words in the FIFO, where n is the empty offset value. Continuing read operations will cause the FIFO to become empty. When the last word has been read from the FIFO, the \overline{EF} will go LOW inhibiting further read operations. \overline{REN} is ignored when the FIFO is empty.

When configured in IDT Standard mode, the \overline{EF} and \overline{FF} outputs are double register-buffered outputs.

Relevant timing diagrams for IDT Standard mode can be found in Figure 7, 8, 11 and 13.

FIRST WORD FALL THROUGH MODE (FWFT)

In this mode, the status flags, \overline{IR} , \overline{PAF} , \overline{HF} , \overline{PAE} , and \overline{OR} operate in the manner outlined in Table 4. To write data into the FIFO, \overline{WEN} must be LOW. Data presented to the DATA IN lines will be clocked into the FIFO on subsequent transitions of WCLK. After the first write is performed, the Output Ready (\overline{OR}) flag will go LOW. Subsequent writes will continue to fill up the FIFO. \overline{PAE} will go HIGH after $n + 2$ words have been loaded into the FIFO, where n is the empty offset value. The default setting for these values are stated in the footnote of Table 2. This parameter is also user programmable. See section on Programmable Flag Offset Loading.

If one continued to write data into the FIFO, and we assumed no read operations were taking place, the \overline{HF} would toggle to LOW once the 514th word for the IDT72V3640, 1,026th word for the IDT72V3650, 2,050th word for the IDT72V3660, 4,098th word for the IDT72V3670, 8,194th word for the IDT72V3680, 16,386th word for the IDT72V3690, 32,770th word for the IDT72V36100 and 65,538th word for the IDT72V36110, respectively was written into the FIFO. Continuing to write data into the FIFO will cause the \overline{PAF} to go LOW. Again, if no reads are performed, the \overline{PAF} will go LOW after (1,025- m) writes for the IDT72V3640, (2,049- m) writes for the IDT72V3650, (4,097- m) writes for the IDT72V3660 and (8,193- m) writes for the IDT72V3670, 16,385 writes for the IDT72V3680, 32,769 writes for the IDT72V3690, 65,537 writes for the IDT72V36100 and 131,073 writes for the IDT72V36110, where m is the full offset value. The default setting for these values are stated in the footnote of Table 2.

When the FIFO is full, the Input Ready (\overline{IR}) flag will go HIGH, inhibiting further write operations. If no reads are performed after a reset, \overline{IR} will go HIGH after D writes to the FIFO. $D = 1,025$ writes for the IDT72V3640, 2,049 writes for the IDT72V3650, 4,097 writes for the IDT72V3660 and 8,193 writes for the IDT72V3670, 16,385 writes for the IDT72V3680, 32,769 writes for the IDT72V3690, 65,537 writes for the IDT72V36100 and 131,073 writes for the IDT72V36110, respectively. Note that the additional word in FWFT mode is due to the capacity of the memory plus output register.

If the FIFO is full, the first read operation will cause the \overline{IR} flag to go LOW. Subsequent read operations will cause the \overline{PAF} and \overline{HF} to go HIGH at the conditions described in Table 4. If further read operations occur, without write operations, the \overline{PAE} will go LOW when there are $n + 1$ words in the FIFO, where n is the empty offset value. Continuing read operations will cause the FIFO to become empty. When the last word has been read from the FIFO, \overline{OR} will go HIGH inhibiting further read operations. \overline{REN} is ignored when the FIFO is empty.

When configured in FWFT mode, the \overline{OR} flag output is triple register-buffered, and the \overline{IR} flag output is double register-buffered.

Relevant timing diagrams for FWFT mode can be found in Figure 9, 10, 12, and 14.

TABLE 2 — DEFAULT PROGRAMMABLE FLAG OFFSETS

IDT72V3640, 72V3650			
$\overline{\text{LD}}$	FSEL1	FSEL0	Offsets n,m
L	H	L	511
L	L	H	255
L	L	L	127
L	H	H	63
H	L	L	31
H	H	L	15
H	L	H	7
H	H	H	3
$\overline{\text{LD}}$	FSEL1	FSEL0	Program Mode
H	X	X	Serial ⁽³⁾
L	X	X	Parallel ⁽⁴⁾
IDT72V3660, 72V3670, 72V3680, 72V3690			
$\overline{\text{LD}}$	FSEL1	FSEL0	Offsets n,m
H	L	L	1,023
L	H	L	511
L	L	H	255
L	L	L	127
L	H	H	63
H	H	L	31
H	L	H	15
H	H	H	7
$\overline{\text{LD}}$	FSEL1	FSEL0	Program Mode
H	X	X	Serial ⁽³⁾
L	X	X	Parallel ⁽⁴⁾
IDT72V36100, 72V36110			
$\overline{\text{LD}}$	FSEL1	FSEL0	Offsets n,m
L	H	L	16,383
L	L	H	8,191
L	H	H	4,095
H	H	L	2,047
H	L	L	1,023
H	L	H	511
H	H	H	255
L	L	L	127
$\overline{\text{LD}}$	FSEL1	FSEL0	Program Mode
H	X	X	Serial ⁽³⁾
L	X	X	Parallel ⁽⁴⁾

NOTES:

1. n = empty offset for $\overline{\text{PAE}}$.
2. m = full offset for $\overline{\text{PAF}}$.
3. As well as selecting serial programming mode, one of the default values will also be loaded depending on the state of FSEL0 & FSEL1.
4. As well as selecting parallel programming mode, one of the default values will also be loaded depending on the state of FSEL0 & FSEL1.

PROGRAMMING FLAG OFFSETS

Full and Empty Flag offset values are user programmable. The IDT72V3640/72V3650/72V3660/72V3670/72V3680/72V3690/72V36100/72V36110 have internal registers for these offsets. There are eight default offset values selectable during Master Reset. These offset values are shown in Table 2. Offset values can also be programmed into the FIFO in one of two ways; serial or parallel loading method. The selection of the loading method is done using the $\overline{\text{LD}}$ (Load) pin. During Master Reset, the state of the $\overline{\text{LD}}$ input determines whether serial or parallel flag offset programming is enabled. A HIGH on $\overline{\text{LD}}$ during Master Reset selects serial loading of offset values. A LOW on $\overline{\text{LD}}$ during Master Reset selects parallel loading of offset values.

In addition to loading offset values into the FIFO, it is also possible to read the current offset values. Offset values can be read via the parallel output port Q0-Qn, regardless of the programming mode selected (serial or parallel). It is not possible to read the offset values in serial fashion.

Figure 3, Programmable Flag Offset Programming Sequence, summarizes the control pins and sequence for both serial and parallel programming modes. For a more detailed description, see discussion that follows.

The offset registers may be programmed (and reprogrammed) anytime after Master Reset, regardless of whether serial or parallel programming has been selected. Valid programming ranges are from 0 to D-1.

SYNCHRONOUS vs ASYNCHRONOUS PROGRAMMABLE FLAG TIMING SELECTION

The IDT72V3640/72V3650/72V3660/72V3670/72V3680/72V3690/72V36100/72V36110 can be configured during the Master Reset cycle with either synchronous or asynchronous timing for $\overline{\text{PAF}}$ and $\overline{\text{PAE}}$ flags by use of the PFM pin.

If synchronous $\overline{\text{PAF}}$ / $\overline{\text{PAE}}$ configuration is selected (PFM, HIGH during MRS), the $\overline{\text{PAF}}$ is asserted and updated on the rising edge of WCLK only and not RCLK. Similarly, $\overline{\text{PAE}}$ is asserted and updated on the rising edge of RCLK only and not WCLK. For detail timing diagrams, see Figure 17 for synchronous $\overline{\text{PAF}}$ timing and Figure 18 for synchronous $\overline{\text{PAE}}$ timing.

If asynchronous $\overline{\text{PAF}}$ / $\overline{\text{PAE}}$ configuration is selected (PFM, LOW during MRS), the $\overline{\text{PAF}}$ is asserted LOW on the LOW-to-HIGH transition of WCLK and $\overline{\text{PAF}}$ is reset to HIGH on the LOW-to-HIGH transition of RCLK. Similarly, $\overline{\text{PAE}}$ is asserted LOW on the LOW-to-HIGH transition of RCLK. $\overline{\text{PAE}}$ is reset to HIGH on the LOW-to-HIGH transition of WCLK. For detail timing diagrams, see Figure 19 for asynchronous $\overline{\text{PAF}}$ timing and Figure 20 for asynchronous $\overline{\text{PAE}}$ timing.

TABLE 3— STATUS FLAGS FOR IDT STANDARD MODE

Number of Words in FIFO	IDT72V3640	IDT72V3650	IDT72V3660	IDT72V3670	FF	PAF	HF	PAE	EF
	0	0	0	0	H	H	H	L	L
	1 to $n^{(1)}$	1 to $n^{(1)}$	1 to $n^{(1)}$	1 to $n^{(1)}$	H	H	H	L	H
	(n+1) to 512	(n+1) to 1,024	(n+1) to 2,048	(n+1) to 4,096	H	H	H	H	H
	513 to (1,024-(m+1))	1,025 to (2,048-(m+1))	2,049 to (4,096-(m+1))	4,097 to (8,192-(m+1))	H	H	L	H	H
	(1024-m) to 1,023	(2048-m) to 2,047	(4,096-m) to 4,095	(8,192-m) to 8,191	H	L	L	H	H
	1,024	2,048	4,096	8,192	L	L	L	H	H

Number of Words in FIFO	IDT72V3680	IDT72V3690	IDT72V36100	IDT72V36110	FF	PAF	HF	PAE	EF
	0	0	0	0	H	H	H	L	L
	1 to $n^{(1)}$	1 to $n^{(1)}$	1 to $n^{(1)}$	1 to $n^{(1)}$	H	H	H	L	H
	(n+1) to 8,192	(n+1) to 16,384	(n+1) to 32,768	(n+1) to 65,536	H	H	H	H	H
	8,193 to (16,384-(m+1))	16,385 to (32,768-(m+1))	32,769 to (65,536-(m+1))	65,537 to (131,072-(m+1))	H	H	L	H	H
	(16,384-m) to 16,383	(32,768-m) to 32,767	(65,536-m) to 65,535	(131,072-m) to 131,071	H	L	L	H	H
	16,384	32,768	65,536	131,072	L	L	L	H	H

NOTE:

1. See table 2 for values for n, m.

TABLE 4— STATUS FLAGS FOR FWFT MODE

Number of Words in FIFO	IDT72V3640	IDT72V3650	IDT72V3660	IDT72V3670	IR	PAF	HF	PAE	OR
	0	0	0	0	L	H	H	L	H
	1 to n+1	1 to n+1	1 to n+1	1 to n+1	L	H	H	L	L
	(n+2) to 513	(n+2) to 1,025	(n+2) to 2,049	(n+2) to 4,097	L	H	H	H	L
	514 to (1,025-(m+1))	1,026 to (2,049-(m+1))	2,050 to (4,097-(m+1))	4,098 to (8,193-(m+1))	L	H	L	H	L
	(1,025-m) to 1,024	(2,049-m) to 2,048	(4,097-m) to 4,096	(8,193-m) to 8,192	L	L	L	H	L
	1,025	2,049	4,097	8,193	H	L	L	H	L

Number of Words in FIFO	IDT72V3680	IDT72V3690	IDT72V36100	IDT72V36110	IR	PAF	HF	PAE	OR
	0	0	0	0	L	H	H	L	H
	1 to n+1	1 to n+1	1 to n+1	1 to n+1	L	H	H	L	L
	(n+2) to 8,193	(n+2) to 16,385	(n+2) to 32,769	(n+2) to 65,537	L	H	H	H	L
	8,194 to (16,385-(m+1))	16,386 to (32,769-(m+1))	32,770 to (65,537-(m+1))	65,538 to (131,073-(m+1))	L	H	L	H	L
	(16,385-m) to 16,384	(32,769-m) to 32,768	(65,537-m) to 65,536	(131,073-m) to 131,072	L	L	L	H	L
	16,385	32,769	65,537	131,073	H	L	L	H	L

NOTE:

1. See table 2 for values for n, m.

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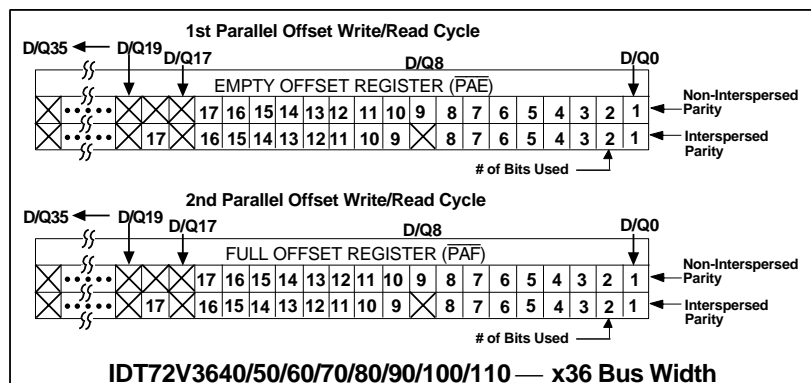
$\overline{\text{LD}}$	$\overline{\text{WEN}}$	$\overline{\text{REN}}$	$\overline{\text{SEN}}$	WCLK	RCLK	IDT72V3640 IDT72V3650 IDT72V3660 IDT72V3670 IDT72V3680 IDT72V3690 IDT72V36100 IDT72V36110
0	0	1	1		X	Parallel write to registers: Empty Offset (LSB) Empty Offset (MSB) Full Offset (LSB) Full Offset (MSB)
0	1	0	1	X		Parallel read from registers: Empty Offset (LSB) Empty Offset (MSB) Full Offset (LSB) Full Offset (MSB)
0	1	1	0		X	Serial shift into registers: 20 bits for the 72V3640 22 bits for the 72V3650 24 bits for the 72V3660 26 bits for the 72V3670 28 bits for the 72V3680 30 bits for the 72V3690 32 bits for the 72V36100 34 bits for the 72V36110 1 bit for each rising WCLK edge Starting with Empty Offset (LSB) Ending with Full Offset (MSB)
X	1	1	1	X	X	No Operation
1	0	X	X		X	Write Memory
1	X	0	X	X		Read Memory
1	1	1	X	X	X	No Operation

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NOTES:

1. The programming method can only be selected at Master Reset.
2. Parallel reading of the offset registers is always permitted regardless of which programming method has been selected.
3. The programming sequence applies to both IDT Standard and FWFT modes.

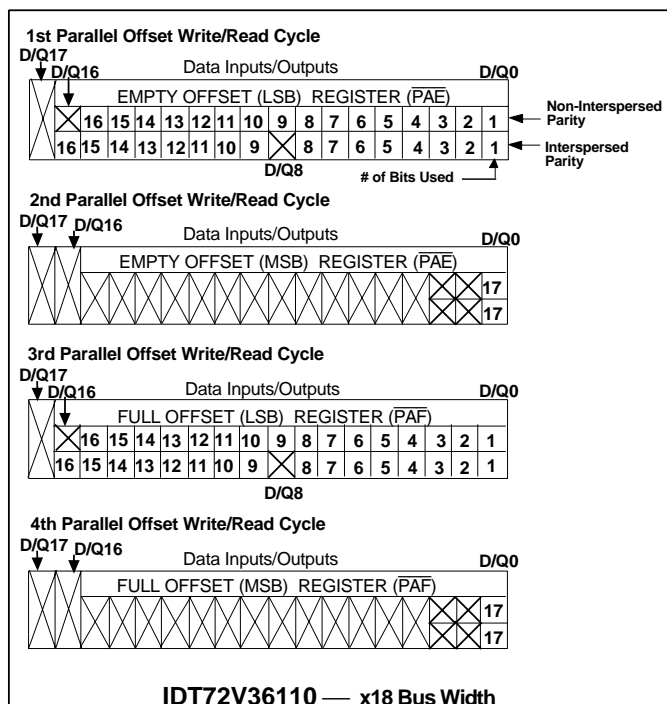
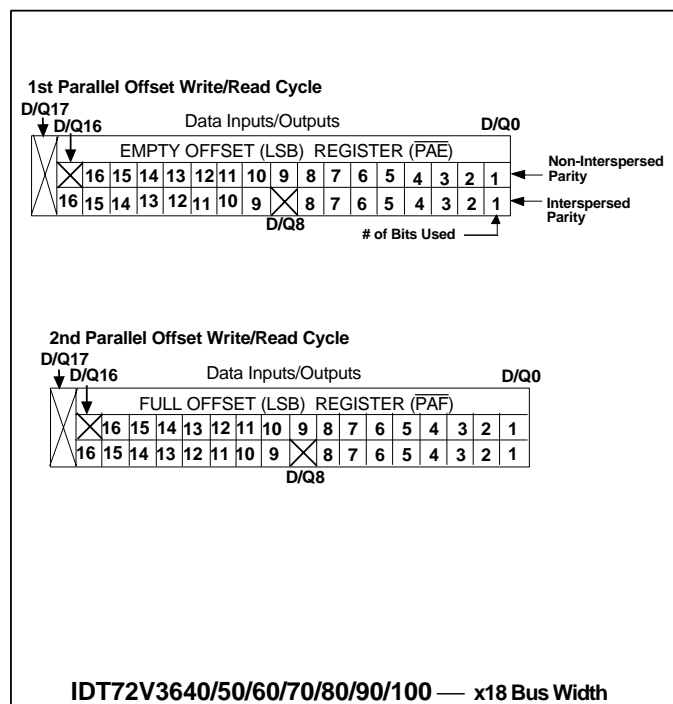
Figure 3. Programmable Flag Offset Programming Sequence



of Bits Used:

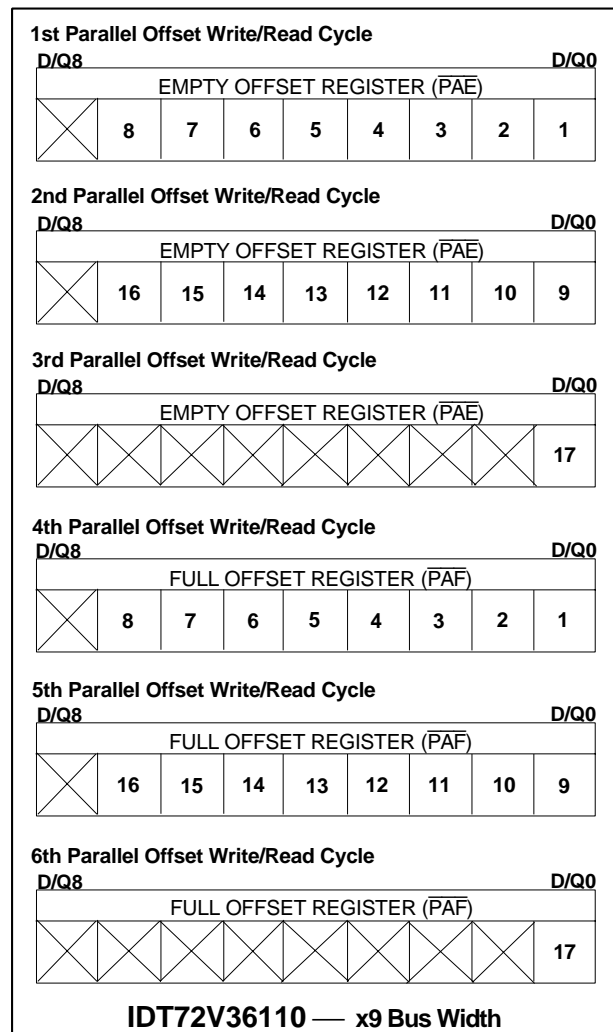
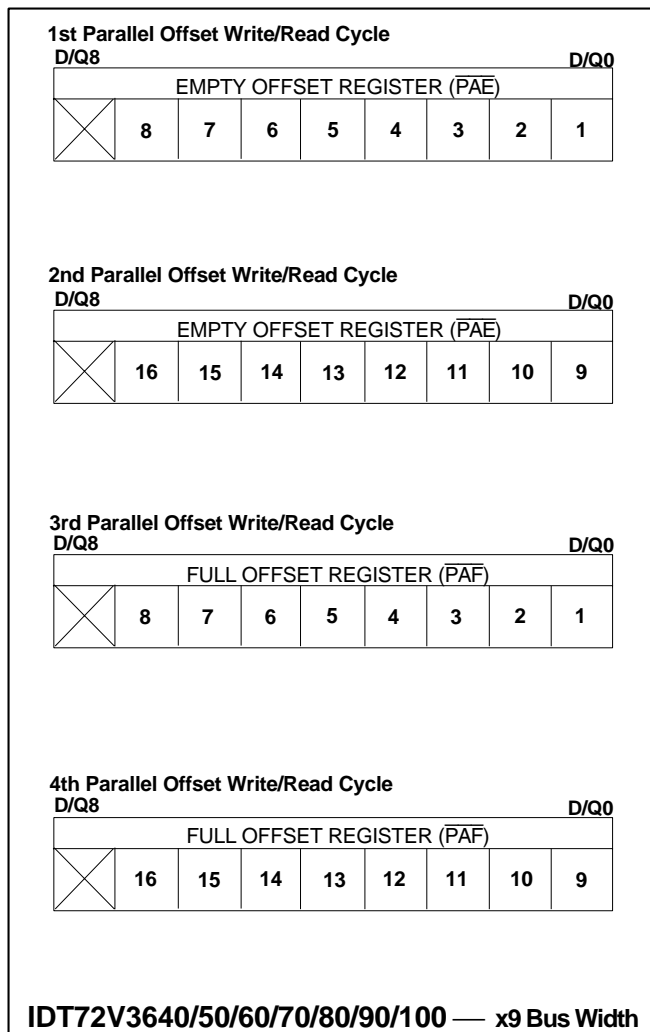
- 10 bits for the IDT72V3640
- 11 bits for the IDT72V3650
- 12 bits for the IDT72V3660
- 13 bits for the IDT72V3670
- 14 bits for the IDT72V3680
- 15 bits for the IDT72V3690
- 16 bits for the IDT72V36100
- 17 bits for the IDT72V36110

Note: All unused bits of the LSB & MSB are don't care



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Figure 3. Programmable Flag Offset Programming Sequence (Continued)



of Bits Used:

10 bits for the IDT72V3640
 11 bits for the IDT72V3650
 12 bits for the IDT72V3660
 13 bits for the IDT72V3670
 14 bits for the IDT72V3680
 15 bits for the IDT72V3690
 16 bits for the IDT72V36100
 17 bits for the IDT72V36110

Note: All unused bits of the
 LSB & MSB are don't care

4667 drw07a

Figure 3. Programmable Flag Offset Programming Sequence (Continued)

SERIAL PROGRAMMING MODE

If Serial Programming mode has been selected, as described above, then programming of PAE and PAF values can be achieved by using a combination of the $\overline{\text{LD}}$, $\overline{\text{SEN}}$, WCLK and SI input pins. Programming PAE and PAF proceeds as follows: when $\overline{\text{LD}}$ and $\overline{\text{SEN}}$ are set LOW, data on the SI input are written, one bit for each WCLK rising edge, starting with the Empty Offset LSB and ending with the Full Offset MSB. A total of 20 bits for the IDT72V3640, 22 bits for the IDT72V3650, 24 bits for the IDT72V3660, 26 bits for the IDT72V3670, 28 bits for the IDT72V3680, 30 bits for the IDT72V3690, 32 bits for the IDT72V36100 and 34 bits for the IDT72V36110. See Figure 15, *Serial Loading of Programmable Flag Registers*, for the timing diagram for this mode.

Using the serial method, individual registers cannot be programmed selectively. PAE and PAF can show a valid status only after the complete set of bits (for all offset registers) has been entered. The registers can be reprogrammed as long as the complete set of new offset bits is entered. When $\overline{\text{LD}}$ is LOW and $\overline{\text{SEN}}$ is HIGH, no serial write to the registers can occur.

Write operations to the FIFO are allowed before and during the serial programming sequence. In this case, the programming of all offset bits does not have to occur at once. A select number of bits can be written to the SI input and then, by bringing $\overline{\text{LD}}$ and $\overline{\text{SEN}}$ HIGH, data can be written to FIFO memory via D_n by toggling $\overline{\text{WEN}}$. When $\overline{\text{WEN}}$ is brought HIGH with $\overline{\text{LD}}$ and $\overline{\text{SEN}}$ restored to a LOW, the next offset bit in sequence is written to the registers via SI. If an interruption of serial programming is desired, it is sufficient either to set $\overline{\text{LD}}$ LOW and deactivate $\overline{\text{SEN}}$ or to set $\overline{\text{SEN}}$ LOW and deactivate $\overline{\text{LD}}$. Once $\overline{\text{LD}}$ and $\overline{\text{SEN}}$ are both restored to a LOW level, serial offset programming continues.

From the time serial programming has begun, neither programmable flag will be valid until the full set of bits required to fill all the offset registers has been written. Measuring from the rising WCLK edge that achieves the above criteria; PAF will be valid after two more rising WCLK edges plus tPAF, PAE will be valid after the next two rising RCLK edges plus tPAE plus tSKEW2.

It is only possible to read the flag offset values via the parallel output port Q_n .

PARALLEL MODE

If Parallel Programming mode has been selected, as described above, then programming of PAE and PAF values can be achieved by using a combination of the $\overline{\text{LD}}$, WCLK, $\overline{\text{WEN}}$ and D_n input pins. Programming PAE and PAF proceeds as follows: $\overline{\text{LD}}$ and $\overline{\text{WEN}}$ must be set LOW. For x36 bit input bus width, data on the inputs D_n are written into the Empty Offset Register on the first LOW-to-HIGH transition of WCLK. Upon the second LOW-to-HIGH transition of WCLK, data are written into the Full Offset Register. The third transition of WCLK writes, once again, to the Empty Offset Register. For x18 bit input bus width, data on the inputs D_n are written into the Empty Offset Register LSB on the first LOW-to-HIGH transition of WCLK. Upon the 2nd LOW-to-HIGH transition of WCLK data are written into the Empty Offset Register MSB. The third transition of WCLK writes to the Full Offset Register LSB, the fourth transition of WCLK then writes to the Full Offset Register MSB. The fifth transition of WCLK writes once again to the Empty Offset Register LSB. A total of four writes to the offset registers is required to load values using a x18 input bus width. For an input bus width of x9 bits, a total of six write cycles to the offset registers is required to load values. See Figure 3, *Programmable Flag Offset Programming Sequence*. See Figure 16, *Parallel Loading of Programmable Flag Registers*, for the timing diagram for this mode.

The act of writing offsets in parallel employs a dedicated write offset register pointer. The act of reading offsets employs a dedicated read offset register pointer. The two pointers operate independently; however, a read and a write should not be performed simultaneously to the offset registers. A Master Reset initializes both pointers to the Empty Offset (LSB) register. A Partial Reset has no effect on the position of these pointers.

Write operations to the FIFO are allowed before and during the parallel programming sequence. In this case, the programming of all offset registers does not have to occur at one time. One, two or more offset registers can be written and then by bringing $\overline{\text{LD}}$ HIGH, write operations can be redirected to the FIFO memory. When $\overline{\text{LD}}$ is set LOW again, and $\overline{\text{WEN}}$ is LOW, the next offset register in sequence is written to. As an alternative to holding $\overline{\text{WEN}}$ LOW and toggling $\overline{\text{LD}}$, parallel programming can also be interrupted by setting $\overline{\text{LD}}$ LOW and toggling $\overline{\text{WEN}}$.

Note that the status of a programmable flag ($\overline{\text{PAE}}$ or $\overline{\text{PAF}}$) output is invalid during the programming process. From the time parallel programming has begun, a programmable flag output will not be valid until the appropriate offset word has been written to the register(s) pertaining to that flag. Measuring from the rising WCLK edge that achieves the above criteria; PAF will be valid after two more rising WCLK edges plus tPAF, PAE will be valid after the next two rising RCLK edges plus tPAE plus tSKEW2.

The act of reading the offset registers employs a dedicated read offset register pointer. The contents of the offset registers can be read on the Q_0 - Q_n pins when $\overline{\text{LD}}$ is set LOW and $\overline{\text{REN}}$ is set LOW. For x36 output bus width, data are read via Q_n from the Empty Offset Register on the first LOW-to-HIGH transition of RCLK. Upon the second LOW-to-HIGH transition of RCLK, data are read from the Full Offset Register. The third transition of RCLK reads, once again, from the Empty Offset Register. For x18 output bus width, a total of four read cycles are required to obtain the values of the offset registers. Starting with the Empty Offset Register LSB and finishing with the Full Offset Register MSB. For x9 output bus width, a total of six read cycles must be performed on the offset registers. See Figure 3, *Programmable Flag Offset Programming Sequence*. See Figure 17, *Parallel Read of Programmable Flag Registers*, for the timing diagram for this mode.

It is permissible to interrupt the offset register read sequence with reads or writes to the FIFO. The interruption is accomplished by deasserting $\overline{\text{REN}}$, $\overline{\text{LD}}$, or both together. When $\overline{\text{REN}}$ and $\overline{\text{LD}}$ are restored to a LOW level, reading of the offset registers continues where it left off. It should be noted, and care should be taken from the fact that when a parallel read of the flag offsets is performed, the data word that was present on the output lines Q_n will be overwritten.

Parallel reading of the offset registers is always permitted regardless of which timing mode (IDT Standard or FWFT modes) has been selected.

RETRANSMIT OPERATION

The Retransmit operation allows data that has already been read to be accessed again. There are 2 modes of Retransmit operation, normal latency and zero latency. There are two stages to Retransmit: first, a setup procedure that resets the read pointer to the first location of memory, then the actual retransmit, which consists of reading out the memory contents, starting at the beginning of memory.

Retransmit setup is initiated by holding $\overline{\text{RT}}$ LOW during a rising RCLK edge. $\overline{\text{REN}}$ and $\overline{\text{WEN}}$ must be HIGH before bringing $\overline{\text{RT}}$ LOW. When zero latency is utilized, $\overline{\text{REN}}$ does not need to be HIGH before bringing $\overline{\text{RT}}$ LOW. At least two words, but no more than D - 2 words should have been written into the FIFO, and read from the FIFO, between Reset (Master or Partial) and the time of Retransmit setup. D = 1,024 for the IDT72V3640, 2,048 for the IDT72V3650, 4,096 for the IDT72V3660, 8,192 for the IDT72V3670, 16,384 for the IDT72V3680, 32,768 for the IDT72V3690, 65,536 for the IDT72V36100 and 131,072 for the IDT72V36110. In FWFT mode, D = 1,025 for the IDT72V2640, 2,049 for the IDT72V3650, 4,097 for the IDT72V3660, 8,193 for the IDT72V3670, 16,385 for the IDT72V3680, 32,769 for the IDT72V3690, 65,537 for the IDT72V36100 and 131,073 for the IDT72V36110.

If IDT Standard mode is selected, the FIFO will mark the beginning of the Retransmit setup by setting $\overline{\text{EF}}$ LOW. The change in level will only be noticeable

if \overline{EF} was HIGH before setup. During this period, the internal read pointer is initialized to the first location of the RAM array.

When \overline{EF} goes HIGH, Retransmit setup is complete and read operations may begin starting with the first location in memory. Since IDT Standard mode is selected, every word read including the first word following Retransmit setup requires a LOW on \overline{REN} to enable the rising edge of RCLK. See Figure 11, *Retransmit Timing (IDT Standard Mode)*, for the relevant timing diagram.

If FWFT mode is selected, the FIFO will mark the beginning of the Retransmit setup by setting \overline{OR} HIGH. During this period, the internal read pointer is set to the first location of the RAM array.

When \overline{OR} goes LOW, Retransmit setup is complete; at the same time, the contents of the first location appear on the outputs. Since FWFT mode is selected, the first word appears on the outputs, no LOW on \overline{REN} is necessary. Reading all subsequent words requires a LOW on \overline{REN} to enable the rising edge of RCLK. See Figure 12, *Retransmit Timing (FWFT Mode)*, for the relevant timing diagram.

For either IDT Standard mode or FWFT mode, updating of the \overline{PAE} , \overline{HF} and \overline{PAF} flags begin with the rising edge of RCLK that \overline{RT} is setup. \overline{PAE} is synchronized to RCLK, thus on the second rising edge of RCLK after \overline{RT} is setup, the \overline{PAE} flag will be updated. \overline{HF} is asynchronous, thus the rising edge of RCLK that \overline{RT} is setup will update \overline{HF} . \overline{PAF} is synchronized to WCLK, thus the second rising edge of WCLK that occurs t_{SKEW} after the rising edge of RCLK that \overline{RT} is setup will update \overline{PAF} . \overline{RT} is synchronized to RCLK.

The Retransmit function has the option of two modes of operation, either "normal latency" or "zero latency". Figure 11 and Figure 12 mentioned previously, relate to "normal latency". Figure 13 and Figure 14 show "zero latency" retransmit operation. Zero latency basically means that the first data word to be retransmitted, is placed onto the output register with respect to the RCLK pulse that initiated the retransmit.

SIGNAL DESCRIPTION

INPUTS:

DATA IN (D₀ - D_n)

Data inputs for 36-bit wide data (D₀ - D₃₅), data inputs for 18-bit wide data (D₀ - D₁₇) or data inputs for 9-bit wide data (D₀ - D₈).

CONTROLS:

MASTER RESET ($\overline{\text{MRS}}$)

A Master Reset is accomplished whenever the $\overline{\text{MRS}}$ input is taken to a LOW state. This operation sets the internal read and write pointers to the first location of the RAM array. $\overline{\text{PAE}}$ will go LOW, $\overline{\text{PAF}}$ will go HIGH, and $\overline{\text{HF}}$ will go HIGH.

If FWFT/SI is LOW during Master Reset then the IDT Standard mode, along with $\overline{\text{EF}}$ and $\overline{\text{FF}}$ are selected. $\overline{\text{EF}}$ will go LOW and $\overline{\text{FF}}$ will go HIGH. If FWFT/SI is HIGH, then the First Word Fall Through mode (FWFT), along with $\overline{\text{IR}}$ and $\overline{\text{OR}}$, are selected. $\overline{\text{OR}}$ will go HIGH and $\overline{\text{IR}}$ will go LOW.

All control settings such as OW, IW, BM, $\overline{\text{BE}}$, RM, PFM and IP are defined during the Master Reset cycle.

During a Master Reset, the output register is initialized to all zeroes. A Master Reset is required after power up, before a write operation can take place. $\overline{\text{MRS}}$ is asynchronous.

See Figure 5, *Master Reset Timing*, for the relevant timing diagram.

PARTIAL RESET ($\overline{\text{PRS}}$)

A Partial Reset is accomplished whenever the $\overline{\text{PRS}}$ input is taken to a LOW state. As in the case of the Master Reset, the internal read and write pointers are set to the first location of the RAM array, $\overline{\text{PAE}}$ goes LOW, $\overline{\text{PAF}}$ goes HIGH, and $\overline{\text{HF}}$ goes HIGH.

Whichever mode is active at the time of Partial Reset, IDT Standard mode or First Word Fall Through, that mode will remain selected. If the IDT Standard mode is active, then $\overline{\text{FF}}$ will go HIGH and $\overline{\text{EF}}$ will go LOW. If the First Word Fall Through mode is active, then $\overline{\text{OR}}$ will go HIGH, and $\overline{\text{IR}}$ will go LOW.

Following Partial Reset, all values held in the offset registers remain unchanged. The programming method (parallel or serial) currently active at the time of Partial Reset is also retained. The output register is initialized to all zeroes. $\overline{\text{PRS}}$ is asynchronous.

A Partial Reset is useful for resetting the device during the course of operation, when reprogramming programmable flag offset settings may not be convenient.

See Figure 6, *Partial Reset Timing*, for the relevant timing diagram.

RETRANSMIT ($\overline{\text{RT}}$)

The Retransmit operation allows data that has already been read to be accessed again. There are 2 modes of Retransmit operation, normal latency and zero latency. There are two stages to Retransmit: first, a setup procedure that resets the read pointer to the first location of memory, then the actual retransmit, which consists of reading out the memory contents, starting at the beginning of the memory.

Retransmit setup is initiated by holding $\overline{\text{RT}}$ LOW during a rising RCLK edge. $\overline{\text{REN}}$ and $\overline{\text{WEN}}$ must be HIGH before bringing $\overline{\text{RT}}$ LOW. When zero latency is utilized, $\overline{\text{REN}}$ does not need to be HIGH before bringing $\overline{\text{RT}}$ LOW.

If IDT Standard mode is selected, the FIFO will mark the beginning of the Retransmit setup by setting $\overline{\text{EF}}$ LOW. The change in level will only be noticeable if $\overline{\text{EF}}$ was HIGH before setup. During this period, the internal read pointer is initialized to the first location of the RAM array.

When $\overline{\text{EF}}$ goes HIGH, Retransmit setup is complete and read operations may begin starting with the first location in memory. Since IDT Standard mode

is selected, every word read including the first word following Retransmit setup requires a LOW on $\overline{\text{REN}}$ to enable the rising edge of RCLK. See Figure 11, *Retransmit Timing (IDT Standard Mode)*, for the relevant timing diagram.

If FWFT mode is selected, the FIFO will mark the beginning of the Retransmit setup by setting $\overline{\text{OR}}$ HIGH. During this period, the internal read pointer is set to the first location of the RAM array.

When $\overline{\text{OR}}$ goes LOW, Retransmit setup is complete; at the same time, the contents of the first location appear on the outputs. Since FWFT mode is selected, the first word appears on the outputs, no LOW on $\overline{\text{REN}}$ is necessary. Reading all subsequent words requires a LOW on $\overline{\text{REN}}$ to enable the rising edge of RCLK. See Figure 12, *Retransmit Timing (FWFT Mode)*, for the relevant timing diagram.

In Retransmit operation, zero latency mode can be selected using the Retransmit Mode (RM) pin during a Master Reset. This can be applied to both IDT Standard mode and FWFT mode.

FIRST WORD FALL THROUGH/SERIAL IN (FWFT/SI)

This is a dual purpose pin. During Master Reset, the state of the FWFT/SI input determines whether the device will operate in IDT Standard mode or First Word Fall Through (FWFT) mode.

If, at the time of Master Reset, FWFT/SI is LOW, then IDT Standard mode will be selected. This mode uses the Empty Flag ($\overline{\text{EF}}$) to indicate whether or not there are any words present in the FIFO memory. It also uses the Full Flag function ($\overline{\text{FF}}$) to indicate whether or not the FIFO memory has any free space for writing. In IDT Standard mode, every word read from the FIFO, including the first, must be requested using the Read Enable ($\overline{\text{REN}}$) and RCLK.

If, at the time of Master Reset, FWFT/SI is HIGH, then FWFT mode will be selected. This mode uses Output Ready ($\overline{\text{OR}}$) to indicate whether or not there is valid data at the data outputs (Q_n). It also uses Input Ready ($\overline{\text{IR}}$) to indicate whether or not the FIFO memory has any free space for writing. In the FWFT mode, the first word written to an empty FIFO goes directly to Q_n after three RCLK rising edges, $\overline{\text{REN}} = \text{LOW}$ is not necessary. Subsequent words must be accessed using the Read Enable ($\overline{\text{REN}}$) and RCLK.

After Master Reset, FWFT/SI acts as a serial input for loading $\overline{\text{PAE}}$ and $\overline{\text{PAF}}$ offsets into the programmable registers. The serial input function can only be used when the serial loading method has been selected during Master Reset. Serial programming using the FWFT/SI pin functions the same way in both IDT Standard and FWFT modes.

WRITE CLOCK (WCLK)

A write cycle is initiated on the rising edge of the WCLK input. Data setup and hold times must be met with respect to the LOW-to-HIGH transition of the WCLK. It is permissible to stop the WCLK. Note that while WCLK is idle, the $\overline{\text{FF}}$ / $\overline{\text{IR}}$, $\overline{\text{PAF}}$ and $\overline{\text{HF}}$ flags will not be updated. (Note that WCLK is only capable of updating $\overline{\text{HF}}$ flag to LOW.) The Write and Read Clocks can either be independent or coincident.

WRITE ENABLE ($\overline{\text{WEN}}$)

When the $\overline{\text{WEN}}$ input is LOW, data may be loaded into the FIFO RAM array on the rising edge of every WCLK cycle if the device is not full. Data is stored in the RAM array sequentially and independently of any ongoing read operation.

When $\overline{\text{WEN}}$ is HIGH, no new data is written in the RAM array on each WCLK cycle.

To prevent data overflow in the IDT Standard mode, $\overline{\text{FF}}$ will go LOW, inhibiting further write operations. Upon the completion of a valid read cycle, $\overline{\text{FF}}$ will go HIGH allowing a write to occur. The $\overline{\text{FF}}$ is updated by two WCLK cycles + tsKEW after the RCLK cycle.

To prevent data overflow in the FWFT mode, \overline{IR} will go HIGH, inhibiting further write operations. Upon the completion of a valid read cycle, \overline{IR} will go LOW allowing a write to occur. The \overline{IR} flag is updated by two WCLK cycles + tsKEW after the valid RCLK cycle.

\overline{WEN} is ignored when the FIFO is full in either FWFT or IDT Standard mode.

READ CLOCK (RCLK)

A read cycle is initiated on the rising edge of the RCLK input. Data can be read on the outputs, on the rising edge of the RCLK input. It is permissible to stop the RCLK. Note that while RCLK is idle, the $\overline{EF/OR}$, \overline{PAE} and \overline{HF} flags will not be updated. (Note that RCLK is only capable of updating the \overline{HF} flag to HIGH.) The Write and Read Clocks can be independent or coincident.

READ ENABLE (\overline{REN})

When Read Enable is LOW, data is loaded from the RAM array into the output register on the rising edge of every RCLK cycle if the device is not empty.

When the \overline{REN} input is HIGH, the output register holds the previous data and no new data is loaded into the output register. The data outputs Q0-Qn maintain the previous data value.

In the IDT Standard mode, every word accessed at Qn, including the first word written to an empty FIFO, must be requested using \overline{REN} . When the last word has been read from the FIFO, the Empty Flag (\overline{EF}) will go LOW, inhibiting further read operations. \overline{REN} is ignored when the FIFO is empty. Once a write is performed, \overline{EF} will go HIGH allowing a read to occur. The \overline{EF} flag is updated by two RCLK cycles + tsKEW after the valid WCLK cycle.

In the FWFT mode, the first word written to an empty FIFO automatically goes to the outputs Qn, on the third valid LOW-to-HIGH transition of RCLK + tsKEW after the first write. \overline{REN} does not need to be asserted LOW. In order to access all other words, a read must be executed using \overline{REN} . The RCLK LOW-to-HIGH transition after the last word has been read from the FIFO, Output Ready (\overline{OR}) will go HIGH with a true read (RCLK with \overline{REN} = LOW), inhibiting further read operations. \overline{REN} is ignored when the FIFO is empty.

SERIAL ENABLE (\overline{SEN})

The \overline{SEN} input is an enable used only for serial programming of the offset registers. The serial programming method must be selected during Master Reset. \overline{SEN} is always used in conjunction with \overline{LD} . When these lines are both LOW, data at the SI input can be loaded into the program register one bit for each LOW-to-HIGH transition of WCLK.

When \overline{SEN} is HIGH, the programmable registers retains the previous settings and no offsets are loaded. \overline{SEN} functions the same way in both IDT Standard and FWFT modes.

OUTPUT ENABLE (\overline{OE})

When Output Enable is enabled (LOW), the parallel output buffers receive data from the output register. When \overline{OE} is HIGH, the output data bus (Qn) goes into a high impedance state.

LOAD (\overline{LD})

This is a dual purpose pin. During Master Reset, the state of the \overline{LD} input, along with FSEL0 and FSEL1, determines one of eight default offset values for the \overline{PAE} and \overline{PAF} flags, along with the method by which these offset registers can be programmed, parallel or serial (see Table 2). After Master Reset, \overline{LD} enables write operations to and read operations from the offset registers. Only the offset loading method currently selected can be used to write to the registers. Offset registers can be read only in parallel.

After Master Reset, the \overline{LD} pin is used to activate the programming process of the flag offset values \overline{PAE} and \overline{PAF} . Pulling \overline{LD} LOW will begin a serial loading or parallel load or read of these offset values.

BUS-MATCHING (BM, IW, OW)

The pins BM, IW and OW are used to define the input and output bus widths. During Master Reset, the state of these pins is used to configure the device bus sizes. See Table 1 for control settings. All flags will operate on the word/byte size boundary as defined by the selection of bus width. See Figure 4 for *Bus-Matching Byte Arrangement*.

BIG-ENDIAN/LITTLE-ENDIAN (\overline{BE})

During Master Reset, a LOW on \overline{BE} will select Big-Endian operation. A HIGH on \overline{BE} during Master Reset will select Little-Endian format. This function is useful when the following input to output bus widths are implemented: x36 to x18, x36 to x9, x18 to x36 and x9 to x36. If Big-Endian mode is selected, then the most significant byte (word) of the long word written into the FIFO will be read out of the FIFO first, followed by the least significant byte. If Little-Endian format is selected, then the least significant byte of the long word written into the FIFO will be read out first, followed by the most significant byte. The mode desired is configured during master reset by the state of the Big-Endian (\overline{BE}) pin. See Figure 4 for *Bus-Matching Byte Arrangement*.

PROGRAMMABLE FLAG MODE (PFM)

During Master Reset, a LOW on PFM will select Asynchronous Programmable flag timing mode. A HIGH on PFM will select Synchronous Programmable flag timing mode. If asynchronous $\overline{PAF/PAE}$ configuration is selected (PFM, LOW during \overline{MRS}), the \overline{PAE} is asserted LOW on the LOW-to-HIGH transition of RCLK. \overline{PAE} is reset to HIGH on the LOW-to-HIGH transition of WCLK. Similarly, the \overline{PAF} is asserted LOW on the LOW-to-HIGH transition of WCLK and \overline{PAF} is reset to HIGH on the LOW-to-HIGH transition of RCLK.

If synchronous $\overline{PAE/PAF}$ configuration is selected (PFM, HIGH during \overline{MRS}), the \overline{PAE} is asserted and updated on the rising edge of RCLK only and not WCLK. Similarly, \overline{PAF} is asserted and updated on the rising edge of WCLK only and not RCLK. The mode desired is configured during master reset by the state of the Programmable Flag Mode (PFM) pin.

INTERSPERSED PARITY (IP)

During Master Reset, a LOW on IP will select Non-Interspersed Parity mode. A HIGH will select Interspersed Parity mode. The IP bit function allows the user to select the parity bit in the word loaded into the parallel port (D0-Dn) when programming the flag offsets. If Interspersed Parity mode is selected, then the FIFO will assume that the parity bits are located in bit position D8, D17, D26 and D35 during the parallel programming of the flag offsets. If Non-Interspersed Parity mode is selected, then D8, D17 and D28 are assumed to be valid bits and D32, D33, D34 and D35 are ignored. IP mode is selected during Master Reset by the state of the IP input pin. Interspersed Parity control only has an effect during parallel programming of the offset registers. It does not effect the data written to and read from the FIFO.

OUTPUTS:

FULL FLAG ($\overline{FF/IR}$)

This is a dual purpose pin. In IDT Standard mode, the Full Flag (\overline{FF}) function is selected. When the FIFO is full, \overline{FF} will go LOW, inhibiting further write operations. When \overline{FF} is HIGH, the FIFO is not full. If no reads are performed

after a reset (either \overline{MRS} or \overline{PRS}), \overline{FF} will go LOW after D writes to the FIFO (D = 1,024 for the IDT72V3640, 2,048 for the IDT72V3650, 4,096 for the IDT72V3660, 8,192 for the IDT72V3670, 16,384 for the IDT72V3680, 32,768 for the IDT72V3690, 65,536 for the IDT72V36100 and 131,072 for the IDT72V36110). See Figure 7, *Write Cycle and Full Flag Timing (IDT Standard Mode)*, for the relevant timing information.

In FWFT mode, the Input Ready (\overline{IR}) function is selected. \overline{IR} goes LOW when memory space is available for writing in data. When there is no longer any free space left, \overline{IR} goes HIGH, inhibiting further write operations. If no reads are performed after a reset (either \overline{MRS} or \overline{PRS}), \overline{IR} will go HIGH after D writes to the FIFO (D = 1,025 for the IDT72V3640, 2,049 for the IDT72V3650, 4,097 for the IDT72V3660, 8,193 for the IDT72V3670, 16,385 for the IDT72V3680, 32,769 for the IDT72V3690, 65,537 for the IDT72V36100 and 131,073 for the IDT72V36110). See Figure 9, *Write Timing (FWFT Mode)*, for the relevant timing information.

The \overline{IR} status not only measures the contents of the FIFO memory, but also counts the presence of a word in the output register. Thus, in FWFT mode, the total number of writes necessary to deassert \overline{IR} is one greater than needed to assert \overline{FF} in IDT Standard mode.

$\overline{FF}/\overline{IR}$ is synchronous and updated on the rising edge of WCLK. $\overline{FF}/\overline{IR}$ are double register-buffered outputs.

EMPTY FLAG ($\overline{EF}/\overline{OR}$)

This is a dual purpose pin. In the IDT Standard mode, the Empty Flag (\overline{EF}) function is selected. When the FIFO is empty, \overline{EF} will go LOW, inhibiting further read operations. When \overline{EF} is HIGH, the FIFO is not empty. See Figure 8, *Read Cycle, Empty Flag and First Word Latency Timing (IDT Standard Mode)*, for the relevant timing information.

In FWFT mode, the Output Ready (\overline{OR}) function is selected. \overline{OR} goes LOW at the same time that the first word written to an empty FIFO appears valid on the outputs. \overline{OR} stays LOW after the RCLK LOW to HIGH transition that shifts the last word from the FIFO memory to the outputs. \overline{OR} goes HIGH only with a true read (RCLK with $\overline{REN} = \text{LOW}$). The previous data stays at the outputs, indicating the last word was read. Further data reads are inhibited until \overline{OR} goes LOW again. See Figure 10, *Read Timing (FWFT Mode)*, for the relevant timing information.

$\overline{EF}/\overline{OR}$ is synchronous and updated on the rising edge of RCLK.

In IDT Standard mode, \overline{EF} is a double register-buffered output. In FWFT mode, \overline{OR} is a triple register-buffered output.

PROGRAMMABLE ALMOST-FULL FLAG (\overline{PAF})

The Programmable Almost-Full flag (\overline{PAF}) will go LOW when the FIFO reaches the almost-full condition. In IDT Standard mode, if no reads are performed after reset (\overline{MRS}), \overline{PAF} will go LOW after (D - m) words are written to the FIFO. The \overline{PAF} will go LOW after (1,024-m) writes for the IDT72V3640, (2,048-m) writes for the IDT72V3650, (4,096-m) writes for the IDT72V3660, (8,192-m) writes for the IDT72V3670, (16,384-m) writes for the IDT72V3680, (32,768-m) writes for the IDT72V3690, (65,536-m) writes for the IDT72V36100 and (131,072-m) writes for the IDT72V36110. The offset "m" is the full offset value. The default setting for this value is stated in the footnote of Table 1.

In FWFT mode, the \overline{PAF} will go LOW after (1,025-m) writes for the IDT72V3640, (2,049-m) writes for the IDT72V3650, (4,097-m) writes for the

IDT72V3660 and (8,193-m) writes for the IDT72V3670, (16,385-m) writes for the IDT72V3680, (32,769-m) writes for the IDT72V3690, (65,537-m) writes for the IDT72V36100 and (131,073-m) writes for the IDT72V36110, where m is the full offset value. The default setting for this value is stated in Table 2.

See Figure 18, *Synchronous Programmable Almost-Full Flag Timing (IDT Standard and FWFT Mode)*, for the relevant timing information.

If asynchronous \overline{PAF} configuration is selected, the \overline{PAF} is asserted LOW on the LOW-to-HIGH transition of the Write Clock (WCLK). \overline{PAF} is reset to HIGH on the LOW-to-HIGH transition of the Read Clock (RCLK). If synchronous \overline{PAF} configuration is selected, the \overline{PAF} is updated on the rising edge of WCLK. See Figure 20, *Asynchronous Almost-Full Flag Timing (IDT Standard and FWFT Mode)*.

PROGRAMMABLE ALMOST-EMPTY FLAG (\overline{PAE})

The Programmable Almost-Empty flag (\overline{PAE}) will go LOW when the FIFO reaches the almost-empty condition. In IDT Standard mode, \overline{PAE} will go LOW when there are n words or less in the FIFO. The offset "n" is the empty offset value. The default setting for this value is stated in the footnote of Table 1.

In FWFT mode, the \overline{PAE} will go LOW when there are n+1 words or less in the FIFO. The default setting for this value is stated in Table 2.

See Figure 19, *Synchronous Programmable Almost-Empty Flag Timing (IDT Standard and FWFT Mode)*, for the relevant timing information.

If asynchronous \overline{PAE} configuration is selected, the \overline{PAE} is asserted LOW on the LOW-to-HIGH transition of the Read Clock (RCLK). \overline{PAE} is reset to HIGH on the LOW-to-HIGH transition of the Write Clock (WCLK). If synchronous \overline{PAE} configuration is selected, the \overline{PAE} is updated on the rising edge of RCLK. See Figure 21, *Asynchronous Programmable Almost-Empty Flag Timing (IDT Standard and FWFT Mode)*.

HALF-FULL FLAG (\overline{HF})

This output indicates a half-full FIFO. The rising WCLK edge that fills the FIFO beyond half-full sets \overline{HF} LOW. The flag remains LOW until the difference between the write and read pointers becomes less than or equal to half of the total depth of the device; the rising RCLK edge that accomplishes this condition sets \overline{HF} HIGH.

In IDT Standard mode, if no reads are performed after reset (\overline{MRS} or \overline{PRS}), \overline{HF} will go LOW after (D/2 + 1) writes to the FIFO, where D = 1,024 for the IDT72V3640, 2,048 for the IDT72V3650, 4,096 for the IDT72V3660, 8,192 for the IDT72V3670, 16,384 for the IDT72V3680, 32,768 for the IDT72V3690, 65,536 for the IDT72V36100 and 131,072 for the IDT72V36110.

In FWFT mode, if no reads are performed after reset (\overline{MRS} or \overline{PRS}), \overline{HF} will go LOW after (D-1/2 + 2) writes to the FIFO, where D = 1,025 for the IDT72V3640, 2,049 for the IDT72V3650, 4,097 for the IDT72V3660, 8,193 for the IDT72V3670, 16,385 for the IDT72V3680, 32,769 for the IDT72V3690, 65,537 for the IDT72V36100 and 131,073 for the IDT72V36110.

See Figure 22, *Half-Full Flag Timing (IDT Standard and FWFT Modes)*, for the relevant timing information. Because \overline{HF} is updated by both RCLK and WCLK, it is considered asynchronous.

DATA OUTPUTS (Q0-Qn)

(Q0-Q35) are data outputs for 36-bit wide data, (Q0-Q17) are data outputs for 18-bit wide data or (Q0-Q8) are data outputs for 9-bit wide data.

BYTE ORDER ON INPUT PORT:

D35-D27



D26-D18



D17-D9



D8-D0



Write to FIFO

BYTE ORDER ON OUTPUT PORT:

\overline{BE}	BM	IW	OW
X	L	L	L

Q35-Q27



Q26-Q18



Q17-Q9



Q8-Q0



Read from FIFO

(a) x36 INPUT to x36 OUTPUT

\overline{BE}	BM	IW	OW
L	H	L	L

Q35-Q27



Q26-Q18



Q17-Q9



Q8-Q0



1st: Read from FIFO

Q35-Q27



Q26-Q18



Q17-Q9



Q8-Q0



2nd: Read from FIFO

(b) x36 INPUT to x18 OUTPUT - BIG-ENDIAN

\overline{BE}	BM	IW	OW
H	H	L	L

Q35-Q27



Q26-Q18



Q17-Q9



Q8-Q0



1st: Read from FIFO

Q35-Q27



Q26-Q18



Q17-Q9



Q8-Q0



2nd: Read from FIFO

(c) x36 INPUT to x18 OUTPUT - LITTLE-ENDIAN

\overline{BE}	BM	IW	OW
L	H	L	H

Q35-Q27



Q26-Q18



Q17-Q9



Q8-Q0



1st: Read from FIFO

Q35-Q27



Q26-Q18



Q17-Q9



Q8-Q0



2nd: Read from FIFO

Q35-Q27



Q26-Q18



Q17-Q9



Q8-Q0



3rd: Read from FIFO

Q35-Q27



Q26-Q18



Q17-Q9



Q8-Q0



4th: Read from FIFO

(d) x36 INPUT to x9 OUTPUT - BIG-ENDIAN

\overline{BE}	BM	IW	OW
H	H	L	H

Q35-Q27



Q26-Q18



Q17-Q9



Q8-Q0



1st: Read from FIFO

Q35-Q27



Q26-Q18



Q17-Q9



Q8-Q0



2nd: Read from FIFO

Q35-Q27



Q26-Q18



Q17-Q9



Q8-Q0



3rd: Read from FIFO

Q35-Q27



Q26-Q18



Q17-Q9



Q8-Q0



4th: Read from FIFO

(e) x36 INPUT to x9 OUTPUT - LITTLE-ENDIAN

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Figure 4. Bus-Matching Byte Arrangement

BYTE ORDER ON INPUT PORT:

D35-D27



D26-D18



D17-D9



D8-D0



1st: Write to FIFO

D35-D27



D26-D18



D17-D9



D8-D0



2nd: Write to FIFO

BYTE ORDER ON OUTPUT PORT:

\overline{BE}	BM	IW	OW
L	H	H	L

Q35-Q27



Q26-Q18



Q17-Q9



Q8-Q0



Read from FIFO

(a) x18 INPUT to x36 OUTPUT - BIG-ENDIAN

\overline{BE}	BM	IW	OW
H	H	H	L

Q35-Q27



Q26-Q18



Q17-Q9



Q8-Q0



Read from FIFO

(b) x18 INPUT to x36 OUTPUT - LITTLE-ENDIAN

BYTE ORDER ON INPUT PORT:

D35-D27



D26-D18



D17-D9



D8-D0



1st: Write to FIFO

D35-D27



D26-D18



D17-D9



D8-D0



2nd: Write to FIFO

D35-D27



D26-D18



D17-D9



D8-D0



3rd: Write to FIFO

D35-D27



D26-D18



D17-D9



D8-D0



4th: Write to FIFO

BYTE ORDER ON OUTPUT PORT:

\overline{BE}	BM	IW	OW
L	H	H	H

Q35-Q27



Q26-Q18



Q17-Q9



Q8-Q0



Read from FIFO

(a) x9 INPUT to x36 OUTPUT - BIG-ENDIAN

\overline{BE}	BM	IW	OW
H	H	H	H

Q35-Q27



Q26-Q18



Q17-Q9



Q8-Q0

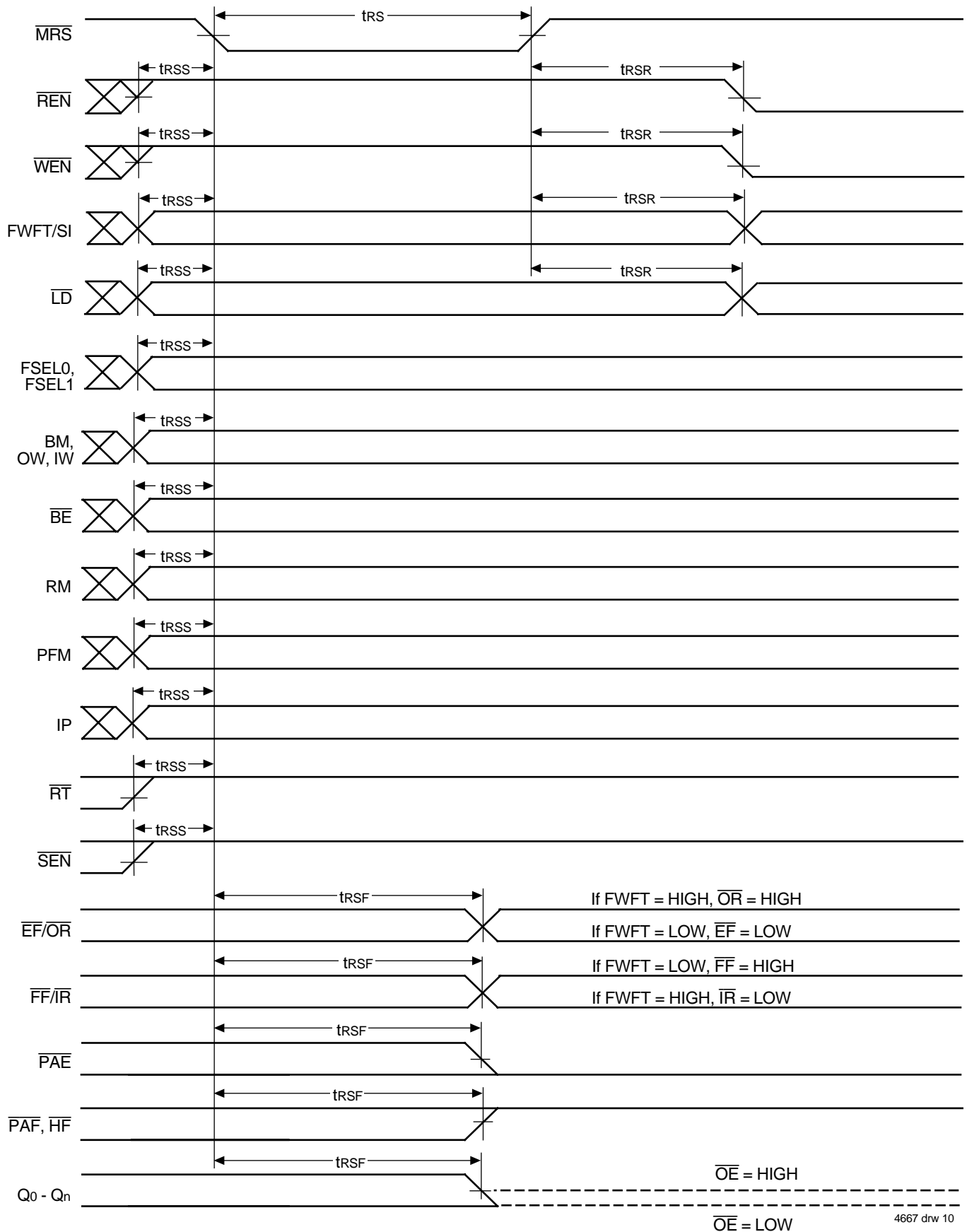


Read from FIFO

(b) x9 INPUT to x36 OUTPUT - LITTLE-ENDIAN

4667 drw 09

Figure 4. Bus-Matching Byte Arrangement (Continued)



4667 drw 10

Figure 5. Master Reset Timing

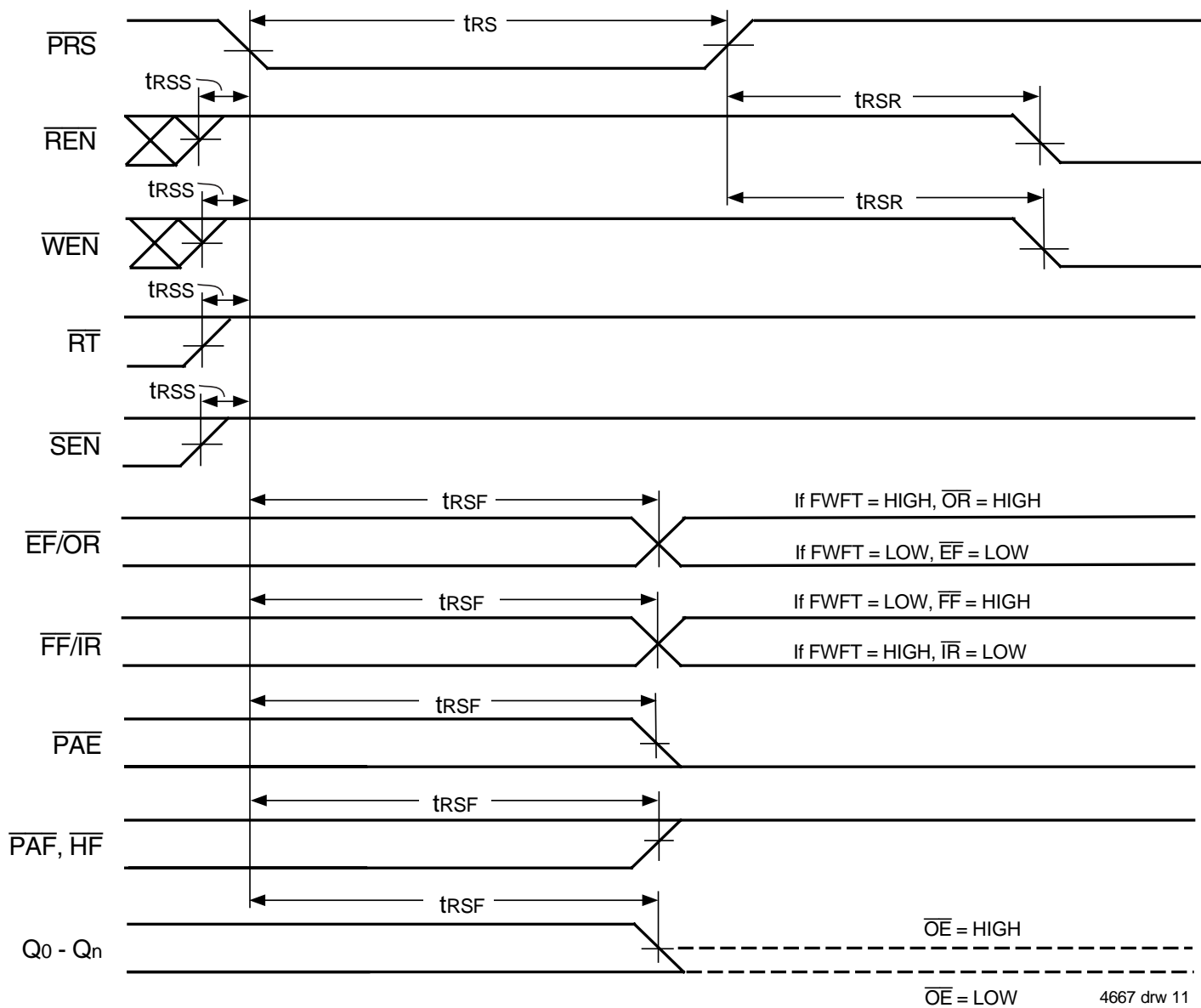
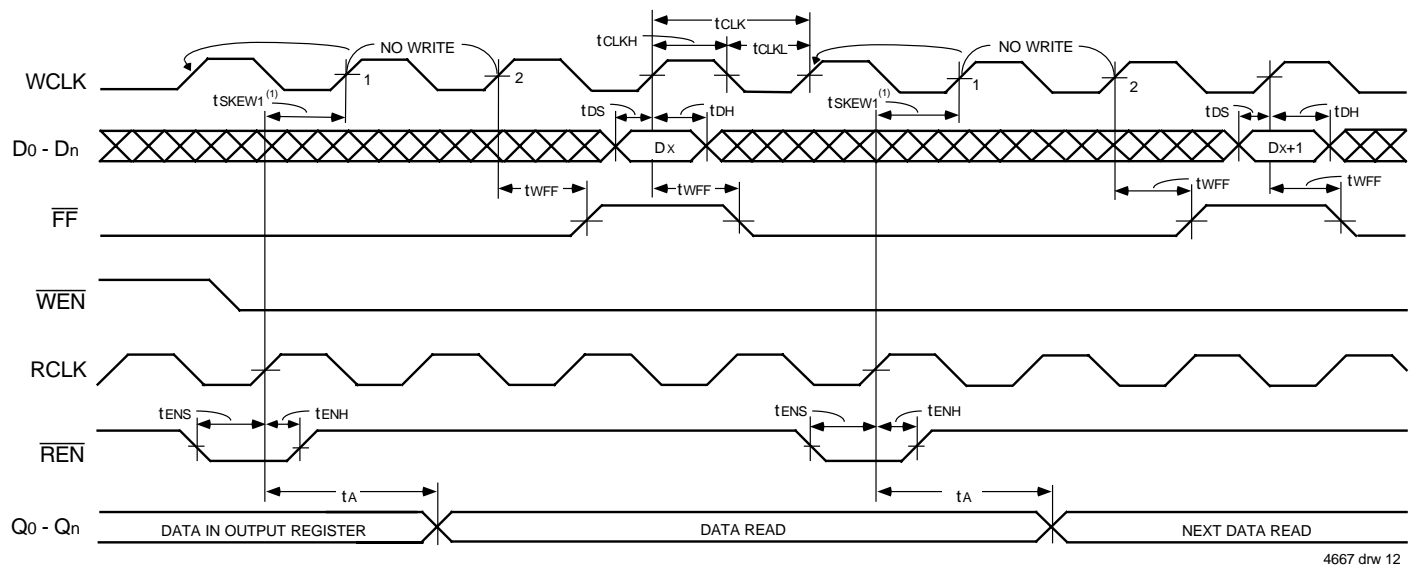


Figure 6. Partial Reset Timing

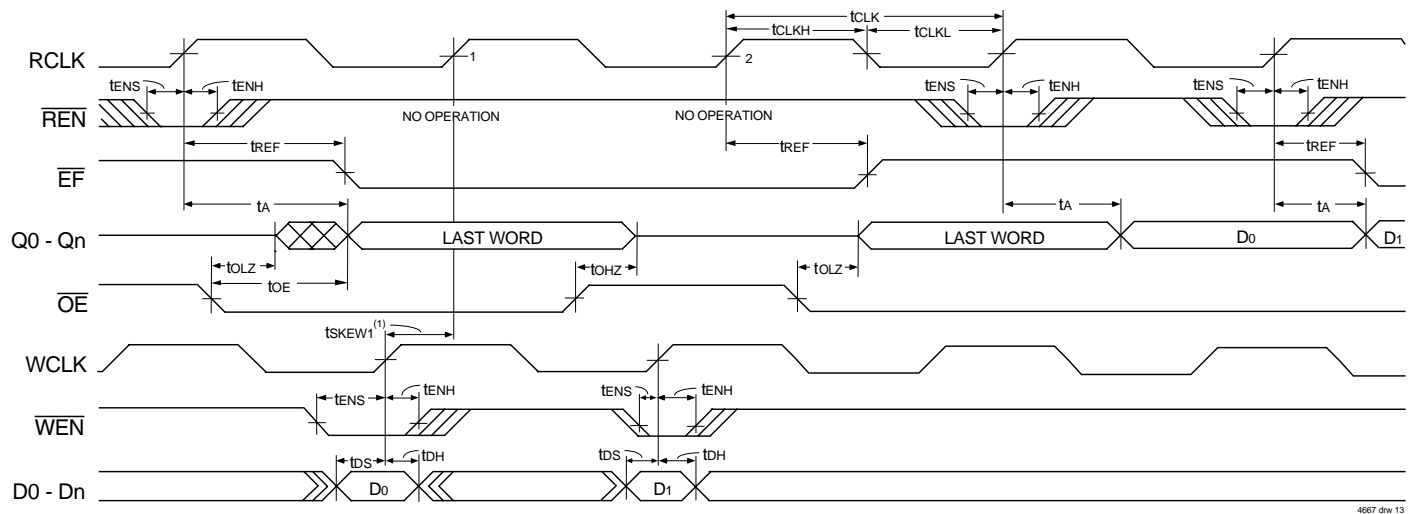


4667 drw 12

NOTES:

1. t_{SKEW1} is the minimum time between a rising RCLK edge and a rising WCLK edge to guarantee that \overline{FF} will go HIGH (after one WCLK cycle plus t_{WFF}). If the time between the rising edge of the RCLK and the rising edge of the WCLK is less than t_{SKEW1} , then the \overline{FF} deassertion may be delayed one extra WCLK cycle.
2. \overline{LD} = HIGH, \overline{OE} = LOW, \overline{EF} = HIGH

Figure 7. Write Cycle and Full Flag Timing (IDT Standard Mode)

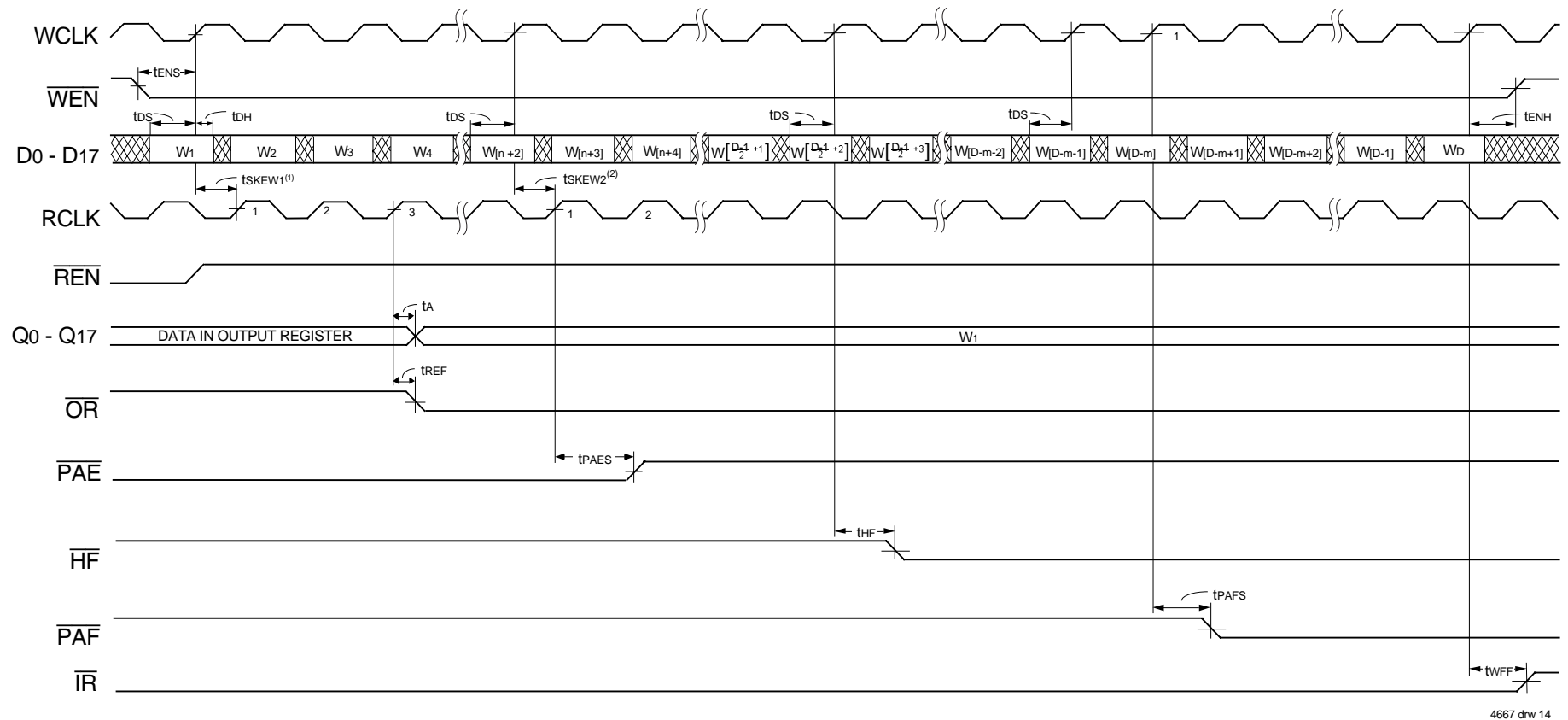


4667 drw 13

NOTES:

1. t_{SKEW1} is the minimum time between a rising WCLK edge and a rising RCLK edge to guarantee that \overline{EF} will go HIGH (after one RCLK cycle plus t_{REF}). If the time between the rising edge of WCLK and the rising edge of RCLK is less than t_{SKEW1} , then \overline{EF} deassertion may be delayed one extra RCLK cycle.
2. \overline{LD} = HIGH.
3. First data word latency = $t_{SKEW1} + 1 \cdot T_{RCLK} + t_{REF}$.

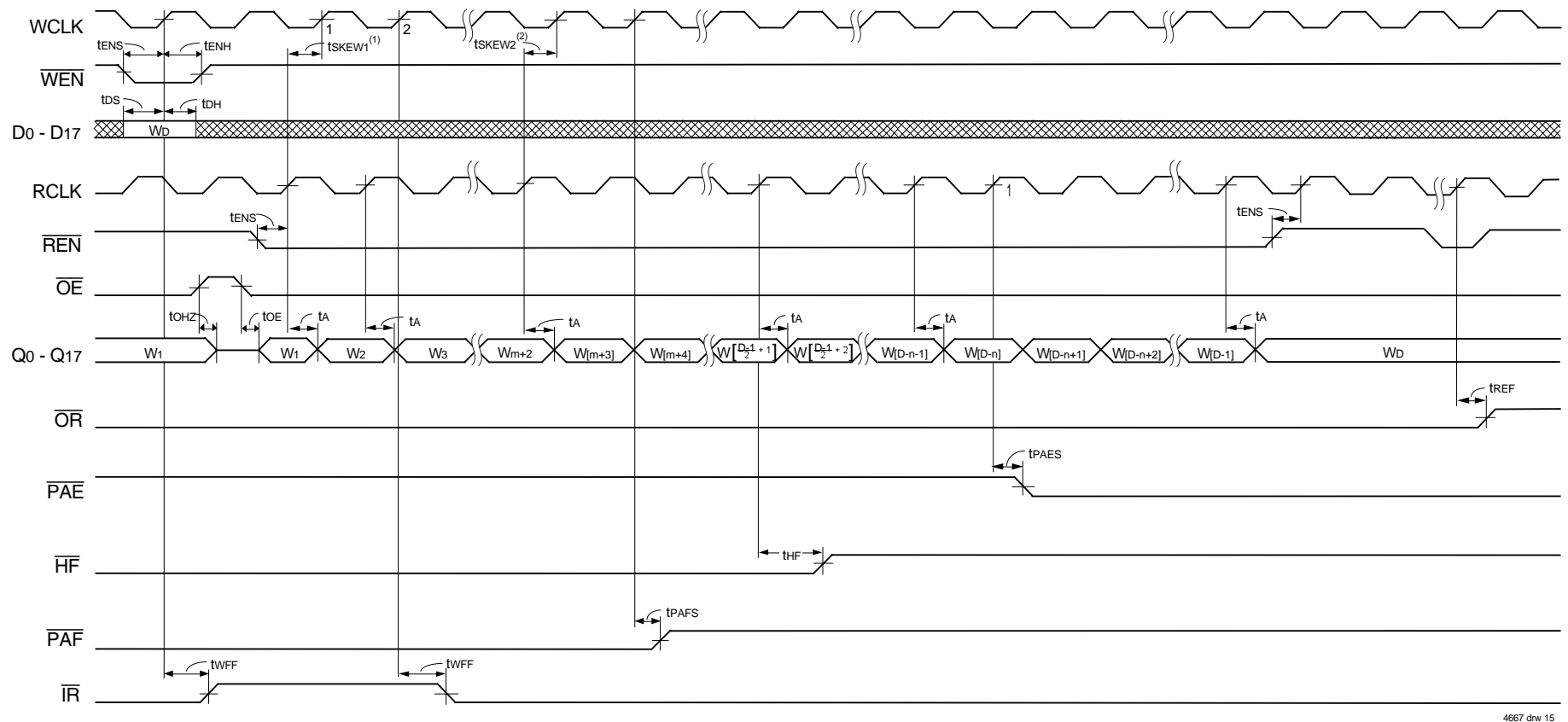
Figure 8. Read Cycle, Empty Flag and First Data Word Latency Timing (IDT Standard Mode)



NOTES:

1. $tsKEW1$ is the minimum time between a rising WCLK edge and a rising RCLK edge to guarantee that \overline{OR} will go LOW after two RCLK cycles plus t_{REF} . If the time between the rising edge of WCLK and the rising edge of RCLK is less than $tsKEW1$, then \overline{OR} assertion may be delayed one extra RCLK cycle.
2. $tsKEW2$ is the minimum time between a rising WCLK edge and a rising RCLK edge to guarantee that \overline{PAE} will go HIGH after one RCLK cycle plus t_{PAES} . If the time between the rising edge of WCLK and the rising edge of RCLK is less than $tsKEW2$, then the \overline{PAE} deassertion may be delayed one extra RCLK cycle.
3. $\overline{LD} = \text{HIGH}$, $\overline{OE} = \text{LOW}$
4. $n = \overline{PAE}$ offset, $m = \overline{PAF}$ offset and $D = \text{maximum FIFO depth}$.
5. $D = 1,025$ for IDT72V3640, 2,049 for IDT72V3650, 4,097 for IDT72V3660, 8,193 for IDT72V3670, 16,385 for the IDT72V3680, 32,769 for the IDT72V3690, 65,537 for the IDT72V36100 and 131,073 for the IDT72V36110.
6. First data word latency = $tsKEW1 + 2 \cdot t_{RCLK} + t_{REF}$.

Figure 9. Write Timing (First Word Fall Through Mode)

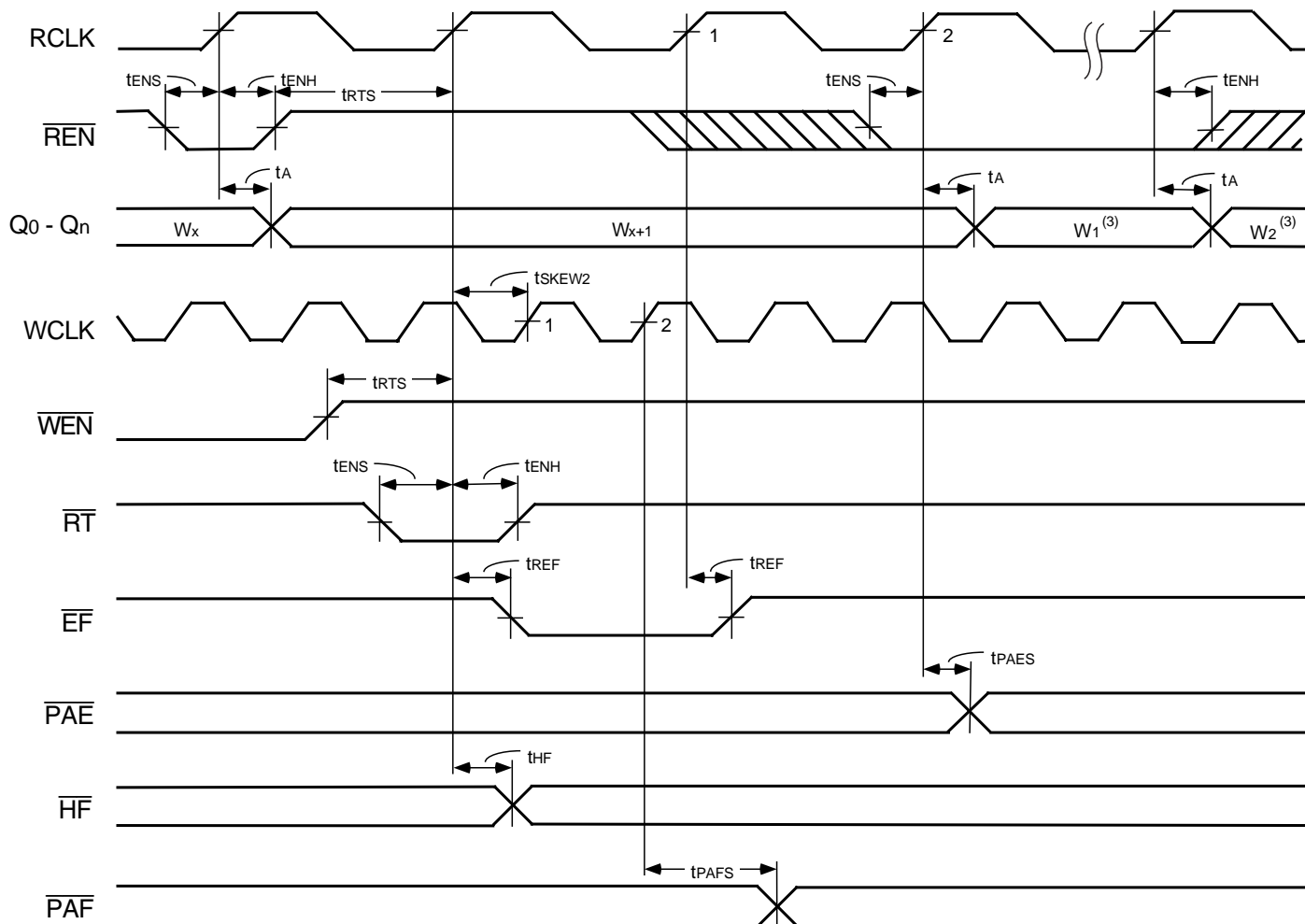


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NOTES:

1. t_{SKEW1} is the minimum time between a rising RCLK edge and a rising WCLK edge to guarantee that \overline{IR} will go LOW after one WCLK cycle plus t_{WFF} . If the time between the rising edge of RCLK and the rising edge of WCLK is less than t_{SKEW1} , then the \overline{IR} assertion may be delayed one extra WCLK cycle.
2. t_{SKEW2} is the minimum time between a rising RCLK edge and a rising WCLK edge to guarantee that \overline{PAF} will go HIGH after one WCLK cycle plus t_{PAFS} . If the time between the rising edge of RCLK and the rising edge of WCLK is less than t_{SKEW2} , then the \overline{PAF} deassertion may be delayed one extra WCLK cycle.
3. \overline{LD} = HIGH
4. n = \overline{PAE} Offset, m = \overline{PAF} offset and D = maximum FIFO depth.
5. D = 1,025 for IDT72V3640, 2,049 for IDT72V3650, 4,097 for IDT72V3660, 8,193 for IDT72V3670, 16,385 for the IDT72V3680, 32,769 for the IDT72V3690, 65,537 for the IDT72V36100 and 131,073 for the IDT72V36110.

Figure 10. Read Timing (First Word Fall Through Mode)

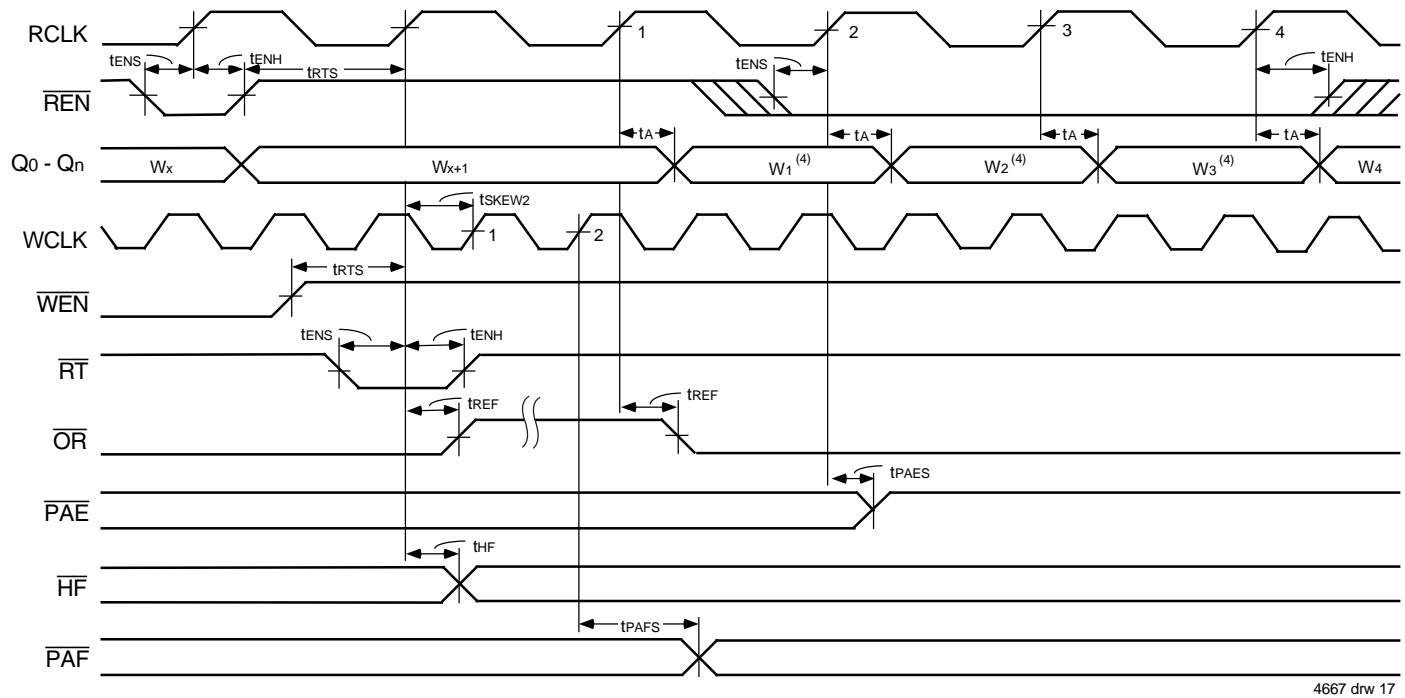


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NOTES:

1. Retransmit setup is complete after \overline{EF} returns HIGH, only then can a read operation begin.
2. \overline{OE} = LOW.
3. W_1 = first word written to the FIFO after Master Reset, W_2 = second word written to the FIFO after Master Reset.
4. No more than $D - 2$ may be written to the FIFO between Reset (Master or Partial) and Retransmit setup. Therefore, \overline{EF} will be HIGH throughout the Retransmit setup procedure. $D = 1,024$ for IDT72V3640, 2,048 for IDT72V3650, 4,096 for IDT72V3660, 8,192 for IDT72V3670, 16,384 for the IDT72V3680, 32,768 for the IDT72V3690, 65,536 for the IDT72V36100 and 131,072 for the IDT72V36110.
5. There must be at least two words written to the FIFO before a Retransmit operation can be invoked.
6. RM is set HIGH during MRS.

Figure 11. Retransmit Timing (IDT Standard Mode)

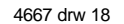


4667 drw 17

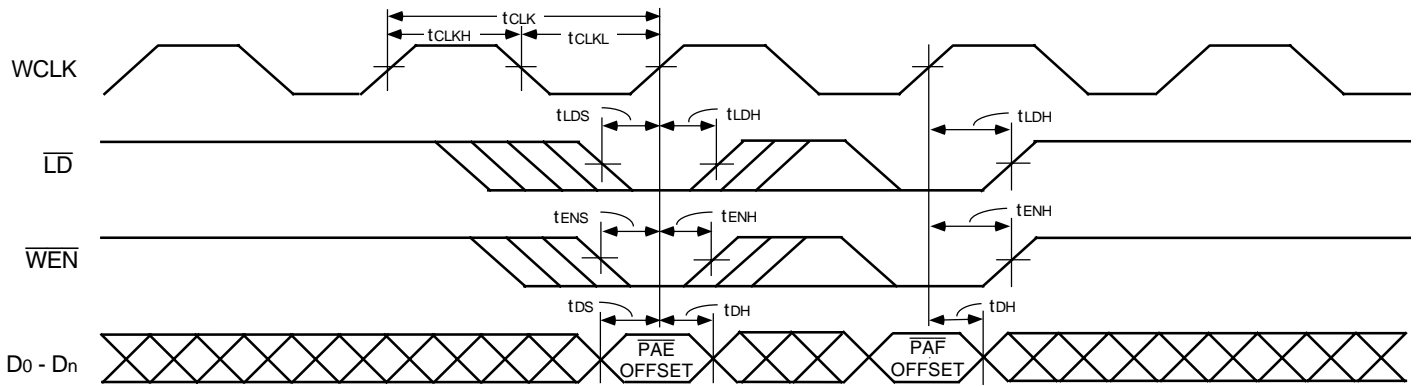
NOTES:

- Retransmit setup is complete after \overline{OR} returns LOW.
- No more than $D - 2$ words may be written to the FIFO between Reset (Master or Partial) and Retransmit setup. Therefore, \overline{IR} will be LOW throughout the Retransmit setup procedure.
 $D = 1,025$ for the IDT72V3640, $2,049$ for the IDT72V3650, $4,097$ for the IDT72V3660, $8,193$ for the IDT72V3670, $16,385$ for the IDT72V3680, $32,769$ for the IDT72V3690, $65,537$ for the IDT72V36100 and $131,073$ for the IDT72V36110.
- $\overline{OE} = \text{LOW}$.
- W_1, W_2, W_3 = first, second and third words written to the FIFO after Master Reset.
- There must be at least two words written to the FIFO before a Retransmit operation can be invoked.
- RM is set HIGH during MRS.

Figure 12. Retransmit Timing (FWFT Mode)



1. If the part is empty at the point of Retransmit, the empty flag (\overline{EF}) will be updated based on RCLK (Retransmit clock cycle), valid data will also appear on the output.
2. \overline{OE} = LOW.
3. W_1 = first word written to the FIFO after Master Reset, W_2 = second word written to the FIFO after Master Reset.
4. No more than D - 2 may be written to the FIFO between Reset (Master or Partial) and Retransmit setup. Therefore, \overline{FF} will be HIGH throughout the Retransmit setup procedure.
D = 1,024 for IDT72V3640, 2,048 for IDT72V3650, 4,096 for IDT72V3660, 8,192 for IDT72V3670, 16,384 for the IDT72V3680, 32,768 for the IDT72V3690, 65,536 for the IDT72V36100 and 131,072 for the IDT72V36110.
5. There must be at least two words written to the FIFO before a Retransmit operation can be invoked.
6. RM is set LOW during MRS.

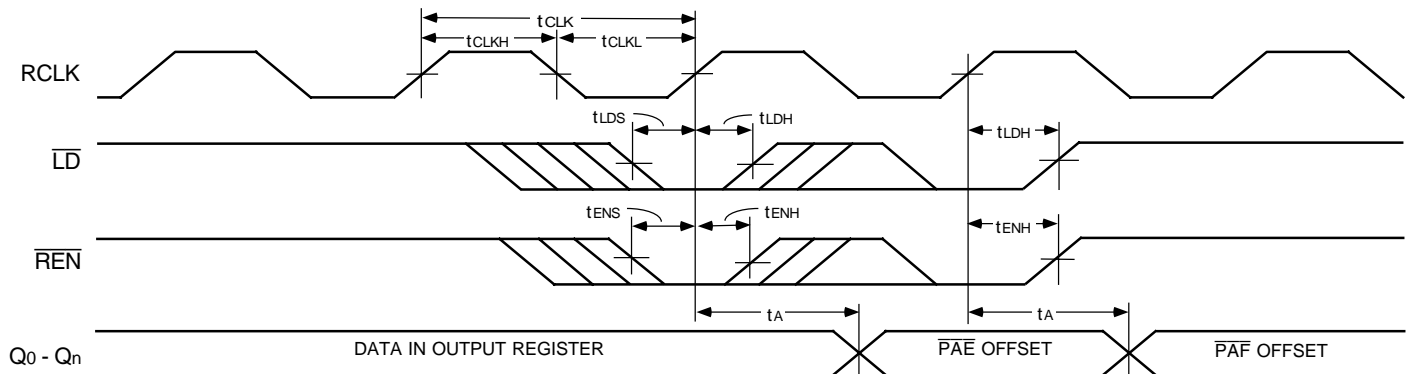


NOTE:

1. This timing diagram illustrates programming with an input bus width of 36 bits.

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Figure 16. Parallel Loading of Programmable Flag Registers (IDT Standard and FWFT Modes)

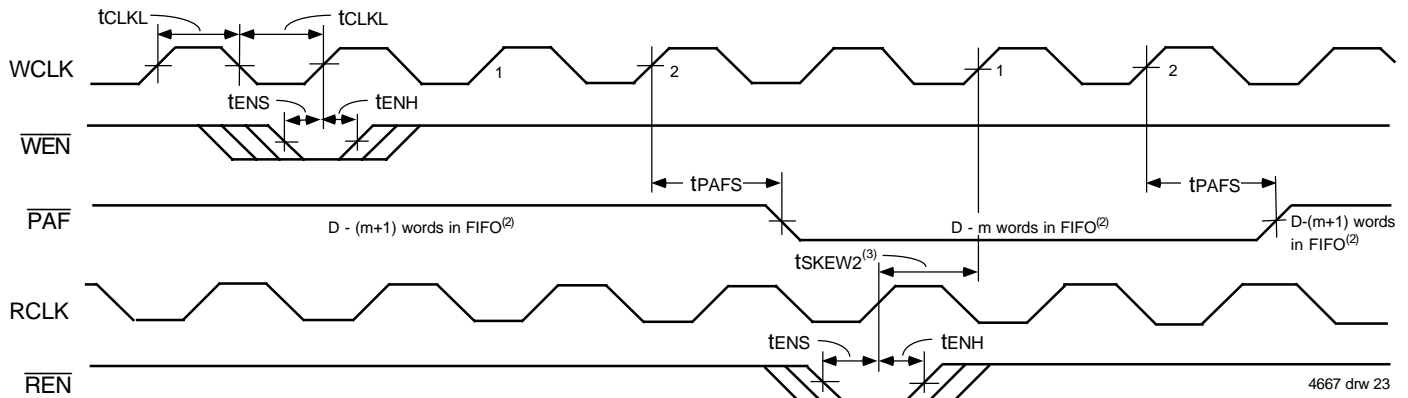


NOTES:

1. OE = LOW.
2. The timing diagram illustrates reading of offset registers with an output bus width of 36 bits.

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Figure 17. Parallel Read of Programmable Flag Registers (IDT Standard and FWFT Modes)

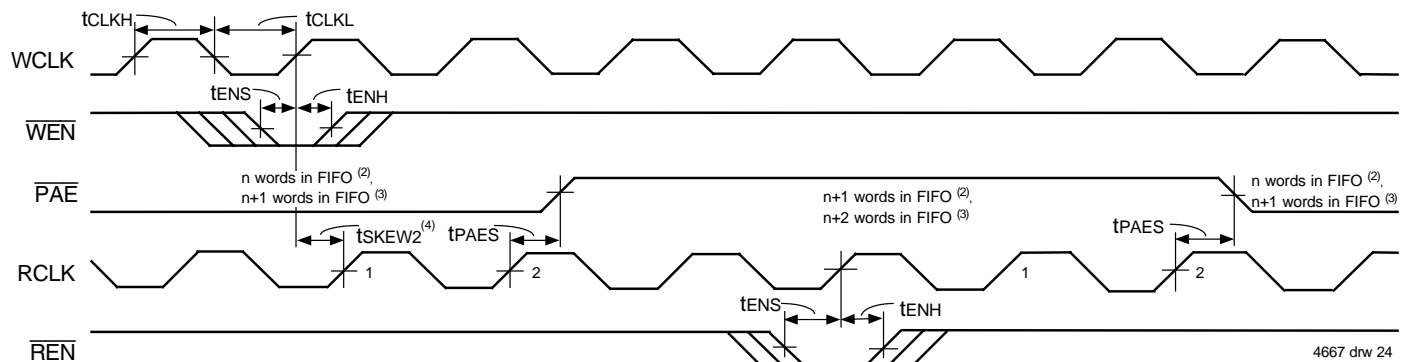


NOTES:

1. $m = \overline{PAF}$ offset.
2. D = maximum FIFO depth.
In IDT Standard mode: $D = 1,024$ for the IDT72V3640, 2,048 for the IDT72V3650, 4,096 for the IDT72V3660 and 8,192 for the IDT72V3670, 16,384 for the IDT72V3680, 32,768 for the IDT72V3690, 65,536 for the IDT72V36100 and 131,072 for the IDT72V36110.
In FWFT mode: $D = 1,025$ for the IDT72V3640, 2,049 for the IDT72V3650, 4,097 for the IDT72V3660, 8,193 for the IDT72V3670, 16,385 for the IDT72V3680, 32,769 for the IDT72V3690, 65,537 for the IDT72V36100 and 131,073 for the IDT72V36110.
3. t_{SKEW2} is the minimum time between a rising RCLK edge and a rising WCLK edge to guarantee that \overline{PAF} will go HIGH (after one WCLK cycle plus t_{PAFS}). If the time between the rising edge of RCLK and the rising edge of WCLK is less than t_{SKEW2} , then the \overline{PAF} deassertion time may be delayed one extra WCLK cycle.
4. \overline{PAF} is asserted and updated on the rising edge of WCLK only.
5. Select this mode by setting PFM HIGH during Master Reset.

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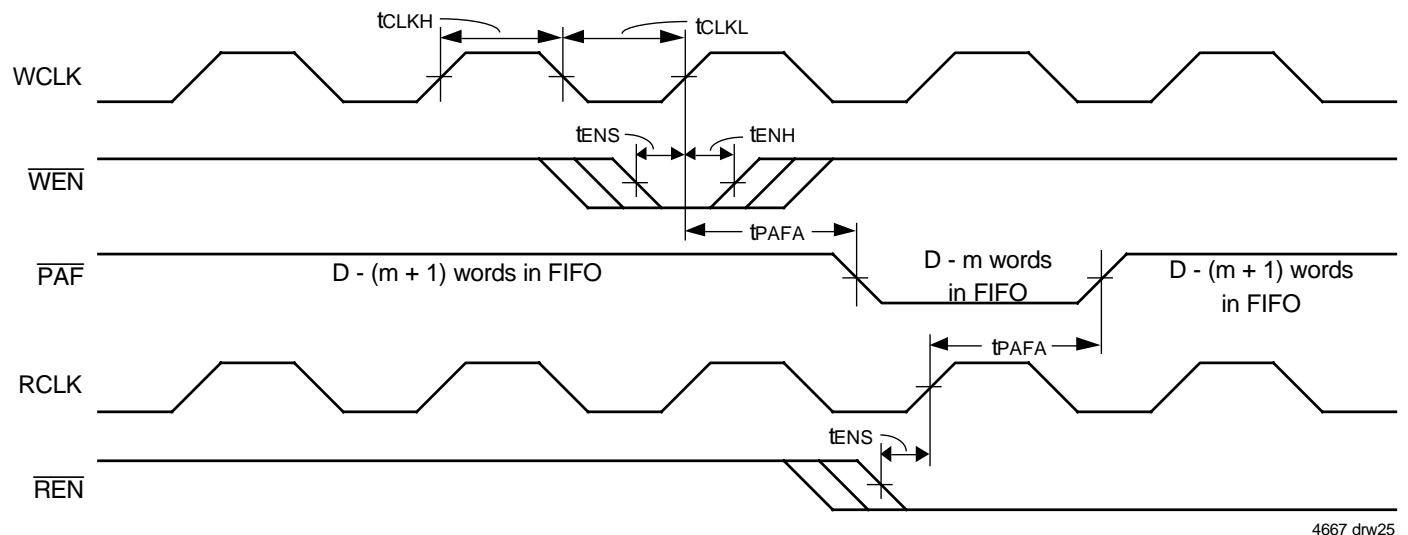
Figure 18. Synchronous Programmable Almost-Full Flag Timing (IDT Standard and FWFT Modes)



NOTES:

1. $n = \overline{\text{PAE}}$ offset.
2. For IDT Standard mode.
3. For FWFT mode.
4. tsKEW2 is the minimum time between a rising WCLK edge and a rising RCLK edge to guarantee that $\overline{\text{PAE}}$ will go HIGH (after one RCLK cycle plus tPAES). If the time between the rising edge of WCLK and the rising edge of RCLK is less than tsKEW2 , then the $\overline{\text{PAE}}$ deassertion may be delayed one extra RCLK cycle.
5. $\overline{\text{PAE}}$ is asserted and updated on the rising edge of WCLK only.
6. Select this mode by setting PFM HIGH during Master Reset.

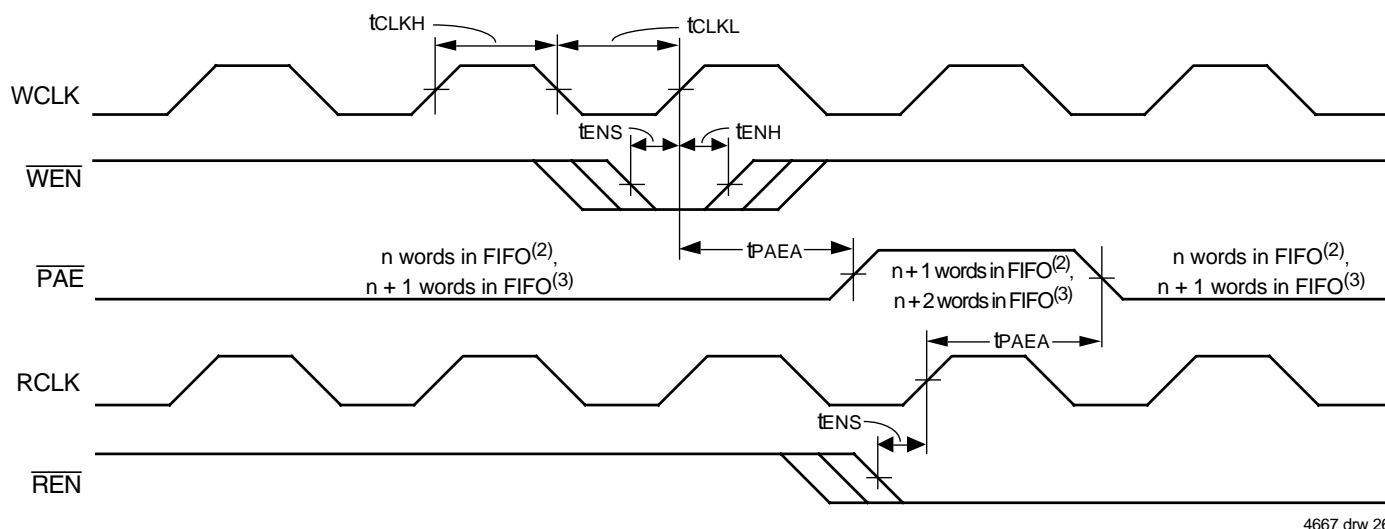
Figure 19. Synchronous Programmable Almost-Empty Flag Timing (IDT Standard and FWFT Modes)



NOTES:

1. $m = \overline{\text{PAF}}$ offset.
2. $D =$ maximum FIFO Depth.
In IDT Standard Mode: $D = 1,024$ for the IDT72V3640, 2,048 for the IDT72V3650, 4,096 for the IDT72V3660, 8,192 for the IDT72V3670, 16,384 for the IDT72V3680, 32,768 for the IDT72V3690, 65,536 for the IDT72V36100 and 131,072 for the IDT72V36110.
In FWFT Mode: $D = 1,025$ for the IDT72V3640, 2,049 for the IDT72V3650, 4,097 for the IDT72V3660, 8,193 for the IDT72V3670, 16,385 for the IDT72V3680, 32,769 for the IDT72V3690, 65,537 for the IDT72V36100 and 131,073 for the IDT72V36110.
3. $\overline{\text{PAF}}$ is asserted to LOW on WCLK transition and reset to HIGH on RCLK transition.
4. Select this mode by setting PFM LOW during Master Reset.

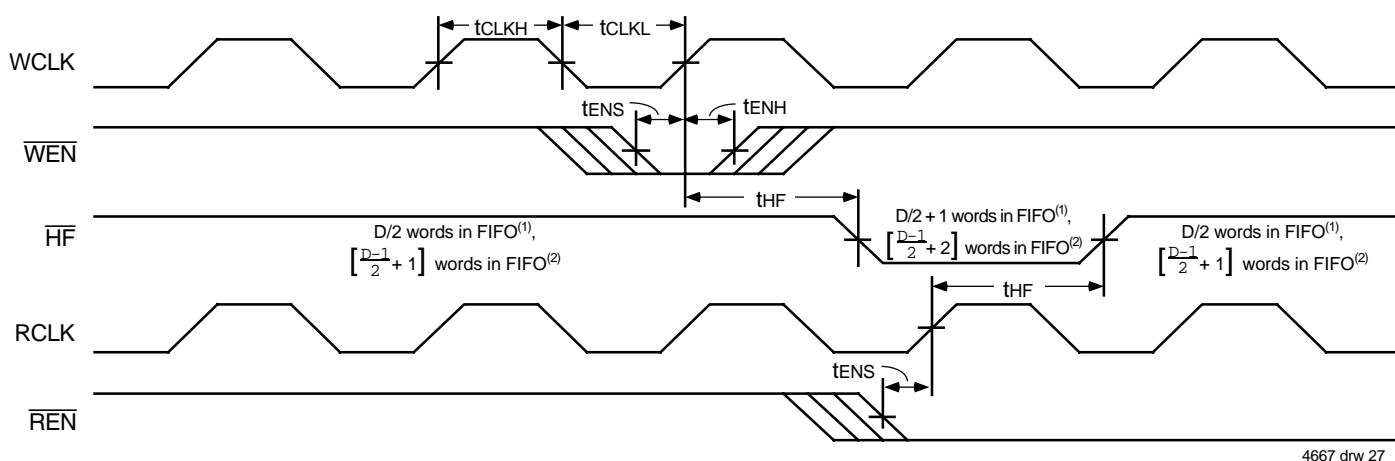
Figure 20. Asynchronous Programmable Almost-Full Flag Timing (IDT Standard and FWFT Modes)



NOTES:

1. $n = \overline{\text{PAE}}$ offset.
2. For IDT Standard Mode.
3. For FWFT Mode.
4. $\overline{\text{PAE}}$ is asserted LOW on RCLK transition and reset to HIGH on WCLK transition.
5. Select this mode by setting PFM LOW during Master Reset.

Figure 21. Asynchronous Programmable Almost-Empty Flag Timing (IDT Standard and FWFT Modes)



NOTES:

1. In IDT Standard mode: D = maximum FIFO depth. D = 1,024 for the IDT72V3640, 2,048 for the IDT72V3650, 4,096 for the IDT72V3660, 8,192 for the IDT72V3670, 16,384 for the IDT72V3680, 32,768 for the IDT72V3690, 65,536 for the IDT72V36100 and 131,072 for the IDT72V36110.
2. In FWFT mode: D = maximum FIFO depth. D = 1,025 for the IDT72V3640, 2,049 for the IDT72V3650, 4,097 for the IDT72V3660, 8,193 for the IDT72V3670, 16,385 for the IDT72V3680, 32,769 for the IDT72V3690, 65,537 for the IDT72V36100 and 131,073 for the IDT72V36110.

Figure 22. Half-Full Flag Timing (IDT Standard and FWFT Modes)

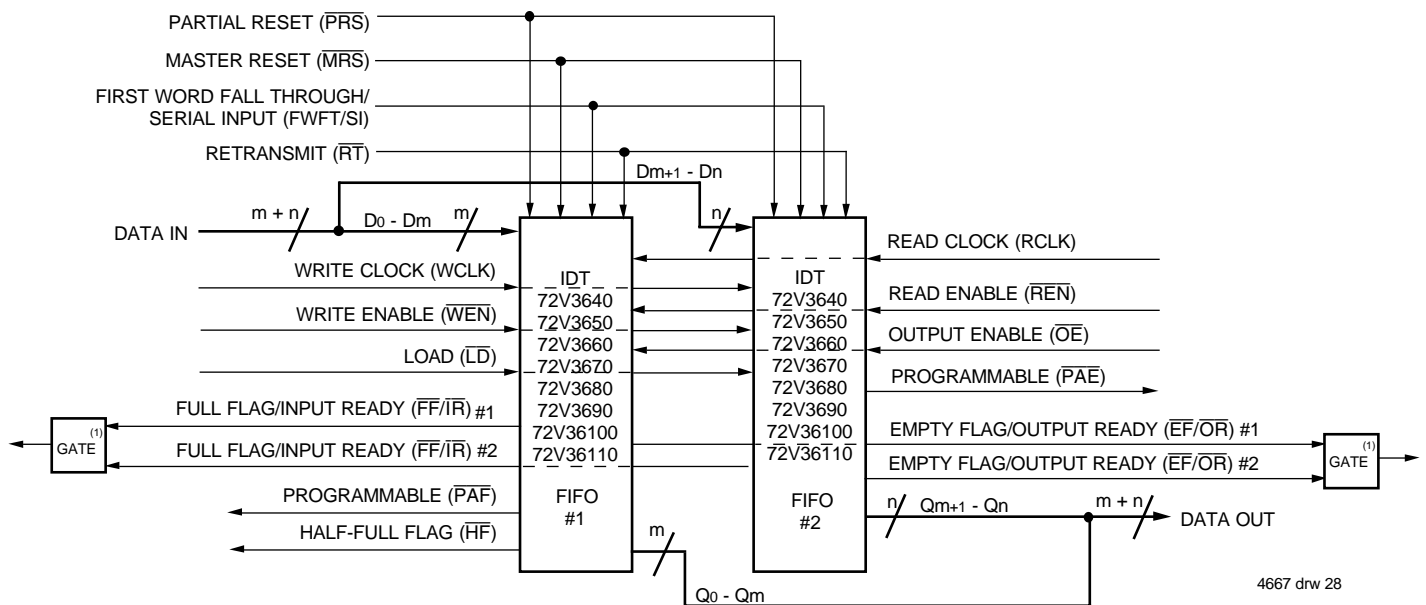
OPTIONAL CONFIGURATIONS

WIDTH EXPANSION CONFIGURATION

Word width may be increased simply by connecting together the control signals of multiple devices. Status flags can be detected from any one device. The exceptions are the \overline{EF} and \overline{FF} functions in IDT Standard mode and the \overline{IR} and \overline{OR} functions in FWFT mode. Because of variations in skew between RCLK and WCLK, it is possible for $\overline{EF}/\overline{FF}$ deassertion and $\overline{IR}/\overline{OR}$ assertion to vary by one cycle between FIFOs. In IDT Standard mode, such problems can be

avoided by creating composite flags, that is, ANDing \overline{EF} of every FIFO, and separately ANDing \overline{FF} of every FIFO. In FWFT mode, composite flags can be created by ORing \overline{OR} of every FIFO, and separately ORing \overline{IR} of every FIFO.

Figure 22 demonstrates a width expansion using two IDT72V3640/72V3650/72V3660/72V3670/72V3680/72V3690/72V36100/72V36110 devices. $D_0 - D_{35}$ from each device form a 72-bit wide input bus and $Q_0 - Q_{35}$ from each device form a 72-bit wide output bus. Any word width can be attained by adding additional IDT72V3640/72V3650/72V3660/72V3670/72V3680/72V3690/72V36100/72V36110 devices.



NOTES:

1. Use an AND gate in IDT Standard mode, an OR gate in FWFT mode.
2. Do not connect any output control signals directly together.
3. FIFO #1 and FIFO #2 must be the same depth, but may be different word widths.

Figure 23. Block Diagram of 1,024 x 72, 2,048 x 72, 4,096 x 72, 8,192 x 72, 16,384 x 72, 32,768 x 72, 65,536 x 72 and 131,072 x 72 Width Expansion

DEPTH EXPANSION CONFIGURATION (FWFT MODE ONLY)

The IDT72V3640 can easily be adapted to applications requiring depths greater than 1,024, 2,048 for the IDT72V3650, 4,096 for the IDT72V3660, 8,192 for the IDT72V3670, 16,384 for the IDT72V3680, 32,768 for the IDT72V3690, 65,536 for the IDT72V36100 and 131,072 for the IDT72V36110 with an 18-bit bus width. In FWFT mode, the FIFOs can be connected in series (the data outputs of one FIFO connected to the data inputs of the next) with no external logic necessary. The resulting configuration provides a total depth equivalent to the sum of the depths associated with each single FIFO. Figure

23 shows a depth expansion using two IDT72V3640/72V3650/72V3660/72V3670/72V3680/72V3690/72V36100/72V36110 devices.

Care should be taken to select FWFT mode during Master Reset for all FIFOs in the depth expansion configuration. The first word written to an empty configuration will pass from one FIFO to the next ("ripple down") until it finally appears at the outputs of the last FIFO in the chain – no read operation is necessary but the RCLK of each FIFO must be free-running. Each time the data word appears at the outputs of one FIFO, that device's \overline{OR} line goes LOW, enabling a write to the next FIFO in line.

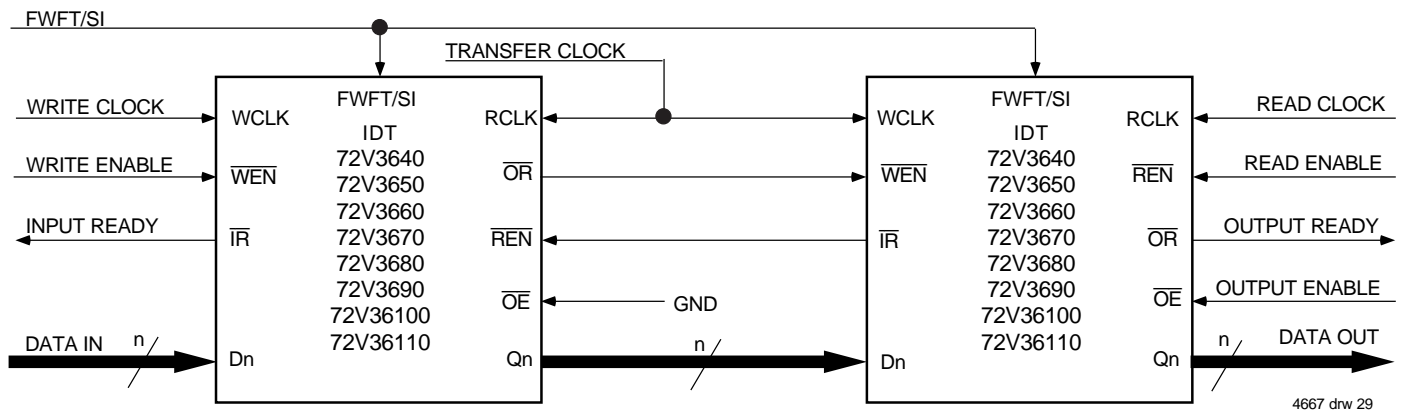


Figure 24. Block Diagram of 2,048 x 36, 4,096 x 36, 8,192 x 36, 16,384 x 36, 32,768 x 36, 65,536 x 36, 131,072 x 36 and 262,144 x 36 Depth Expansion

For an empty expansion configuration, the amount of time it takes for \overline{OR} of the last FIFO in the chain to go LOW (i.e. valid data to appear on the last FIFO's outputs) after a word has been written to the first FIFO is the sum of the delays for each individual FIFO:

$$(N - 1) * (4 * \text{transfer clock}) + 3 * \text{TRCLK}$$

where N is the number of FIFOs in the expansion and TRCLK is the RCLK period. Note that extra cycles should be added for the possibility that the t_{SKEW1} specification is not met between WCLK and transfer clock, or RCLK and transfer clock, for the \overline{OR} flag.

The "ripple down" delay is only noticeable for the first word written to an empty depth expansion configuration. There will be no delay evident for subsequent words written to the configuration.

The first free location created by reading from a full depth expansion configuration will "bubble up" from the last FIFO to the previous one until it finally moves into the first FIFO of the chain. Each time a free location is created in one

FIFO of the chain, that FIFO's \overline{IR} line goes LOW, enabling the preceding FIFO to write a word to fill it.

For a full expansion configuration, the amount of time it takes for \overline{IR} of the first FIFO in the chain to go LOW after a word has been read from the last FIFO is the sum of the delays for each individual FIFO:

$$(N - 1) * (3 * \text{transfer clock}) + 2 * \text{TWCLK}$$

where N is the number of FIFOs in the expansion and TWCLK is the WCLK period. Note that extra cycles should be added for the possibility that the t_{SKEW1} specification is not met between RCLK and transfer clock, or WCLK and transfer clock, for the \overline{IR} flag.

The Transfer Clock line should be tied to either WCLK or RCLK, whichever is faster. Both these actions result in data moving, as quickly as possible, to the end of the chain and free locations to the beginning of the chain.

ORDERING INFORMATION

IDT	XXXXXX	X	XX	X	X	
	Device Type	Power	Speed	Package	Process / Temperature Range	
					BLANK I ⁽¹⁾	Commercial (0°C to +70°C) Industrial (-40°C to +85°C)
					PF	Thin Plastic Quad Flatpack (TQFP, PK128-1)
					7.5 10 15	Commercial Only Commercial Only Com'l & Ind'l
					L	Low Power
					72V3640	1,024 x 36 — 3.3V SuperSync II FIFO
					72V3650	2,048 x 36 — 3.3V SuperSync II FIFO
					72V3660	4,096 x 36 — 3.3V SuperSync II FIFO
					72V3670	8,192 x 36 — 3.3V SuperSync II FIFO
					72V3680	16,384 x 36 — 3.3V SuperSync II FIFO
					72V3690	32,768 x 36 — 3.3V SuperSync II FIFO
					72V36100	65,536 x 36 — 3.3V SuperSync II FIFO
					72V36110	131,072 x 36 — 3.3V SuperSync II FIFO

NOTE:

- Industrial temperature range is available by special order for speed grades faster than 15ns.

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DATASHEET DOCUMENT HISTORY

05/25/2000	pgs. 1, 6, 7, 8, 34 and 35.
07/28/2000	pgs. 13, 14 and 34.
12/14/2000	pgs. 6, 7 and 8.
03/27/2001	pg. 7.
04/06/2001	pgs. 4, 5 and 18.



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